ATOMLAB WIPE TEST COUNTER

OPERATION AND SERVICE MANUAL

086-331





Atomlab Wipe Test Counter



This manual contains operating procedures for the following Biodex product:

#086-331 Atomlab Wipe Test Counter

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Definition of Symbols

The following symbols and their associated definitions are used and implied throughout this manual.

Symbol	Definition
	Carefully read these instructions prior to use
\triangle	Caution
<u>^</u>	General Warning
0	General Mandatory Action
4	Dangerous Voltage
•	"On" Power
0	"Off" Power
<u>_</u>	Earth (ground)
\sim	Alternating Current
\Box	Fuse
֥	USB Connector/Cable
	Waste in Electrical Equipment
M	Date of Manufacture
†	Type B Applied Part
CE	CE Mark
C € 0413	CE Mark for products with EC Certificate
o Intertek	Certified for Safety by ETL Intertek

Before Proceeding



NOTE: The warnings, cautions and instructions provided in this manual must be read, followed and kept available for consultation at all times. Observing the information, instructions and procedures presented throughout this manual is essential for using the Atomlab Wipe Test Counter both properly and safely.



SPECIFIC CAUTIONS

- · Allow only qualified, trained personnel to operate or service this product.
- If the equipment is used in a manner other than specified in this operation manual, the protection provided by the equipment may be impaired and results could be compromised.
- The display operates on low voltage and the power supply auto-ranges from 100 to 240 volts input current. The detector steps up the current to increase the high voltage required to operate the detector. (Never open the detector. The detector should only be opened by experienced, qualified personnel.)
- The Atomlab Wipe Test Counter is designed for use with specific printers. Contact Biodex for compatible printers.
- The pre-set ROIs noted in Appendix D are hard coded and cannot be changed by the user.
- Leave the Atomlab Wipe Test Counter power ON so that the detector remains stable and can quickly provide accurate measurements.

PRUDENCES SPÉCIFIQUES



- · Admettez que le personnel seulement autorisé, entraîné pour opérer ou assurer l'entretien de l'Atomlab Essuie le Comptoir D'essai.
- · Si l'équipement est utilisé dans une manière autre qu'indiqué dans ce manuel d'opération, la protection fournie par l'équipement peut être diminuée et les résultats pourraient être compromis.
- L'étalage opère sur le voltage bas et les auto-gammes d'alimentation électrique du courant de contribution de 100 à 240 volts. Le détecteur augmente le courant pour augmenter le haut voltage exigé de faire marcher le détecteur. (N'ouvrez jamais le détecteur. Le détecteur devrait seulement être ouvert par le personnel expérimenté, qualifié.)
- Les Atomlab Essuient le Comptoir D'essai est conçu à l'utilisation avec les imprimantes spécifiques. Contactez Biodex pour les imprimantes compatibles.
- ROIs programmés notés dans l'Appendice D sont durement codés et ne peuvent pas être changés par l'utilisateur.
- Partez les Atomlab Essuient le pouvoir de Comptoir d'Épreuve SUR pour que le détecteur reste ferme et peut vite fournir des mesures exactes.



WARNING: The unit contains lead for shielding the detector from background radiation. Additional lead shielding can be used outside the detector to further reduce background. The lead should be disposed of in accordance with local and national regulations when disposing of the unit.



AVERTISSEMENT: l'unité contient l'avance pour protéger le détecteur du rayonnement ambiant. Le premier fait de protéger supplémentaire peut être utilisé à l'extérieur du détecteur pour davantage réduire le fond. L'avance devrait être disposée conformément aux règlements locaux et nationaux en se débarrassant de l'unité.

A sealed source should be used for calibration or Constancy of the system each day the system will be used.



WARNING: All activities and count values on the sample reports in this manual are for illustration purposes only. They do not represent actual study values.



AVERTISSEMENT: Toutes les activités et les valeurs de compte sur les rapports de promotion dans ce manuel sont pour les buts d'illustration seulement. Ils ne représentent pas de valeurs d'étude réelles.



CAUTION: Unauthorized modifications to this product are not permitted and will void the manufacturer's warranty. Unauthorized modification of the product may result in a hazard to the user and/or patient. Do not modify this equipment without authorization from the manufacturer.



ATTENTION: Les modifications faites sans autorisation à ce produit ne sont pas permises et va faire le vide la garantie du fabricant. La modification faite sans autorisation du produit peut s'ensuivre dans un hasard à l'utilisateur et-ou le patient. Ne modifiez pas cet équipement sans autorisation du fabricant.



CAUTION: The Atomlab Wipe Test Counter is intended to count and report the removable contamination level of a wipe taken from a designated area or sample.



ATTENTION: Les Atomlab Essuient le Comptoir D'essai est destiné pour compter et annoncer le niveau de contamination amovible du fait d'essuyer pris d'une région désignée ou d'un échantillon.

Training

On-site installation and training is optional. The operation manual includes assembly and operating instructions. An applications training webinar is available on the internet at no charge; application questions can be directed to our service department during business hours.

Product Certifications and Classifications

The Atomlab Wipe Test Counter has received the following certifications, and falls within the following classifications:

- · ETL Listed Electrical Equipment, Laboratory Use; Part 1, General Requirements for Safety conforms to UL 60601-1, CAN/CSA C22.2 No: 601-1-M90, IEC 60601-1, IEC 60601-1-4 and IEC 60601-1-2 and CE Marked.
- · FDA Class II Equipment
- · EC Certificate: EC # 41312458
- · Type B Applied Part





· Electromagnetic Compatibility: This equipment complies with the Medical Equipment ICC60601-2 EMC Standard.

NOTE: Circuit diagrams for this product are provided in the Schematics section at the back of this manual.

Authorized European Community Representative:



Emergo Europe Molenstraat 15 2513 BH, The Hague The Netherlands

Important Safety Information



CAUTION: Federal Law restricts this device to sale by or on the order of a physician, pharmacist or other licensed professional.



ATTENTION: La Loi fédérale limite ce dispositif à vente par ou sur l'ordre d'un médecin, pharmacien ou autre professionnel autorisé.



Follow the unpacking and assembly instructions document.



Before using this device, read the entire operation manual carefully. Failure to read the manual may result in user error or inaccurate data. Be sure to save all provided documents for future reference.



Make certain to understand all warning and caution labels as explained in the Before Proceeding section of this manual.



This product should be used only as specified in this operation manual.



This medical electrical equipment required special precautions regarding EMC an needs to be installed and placed into service according to EMC information provided in this manual. For electromagnetic compliance definition, refer to table of contents.



For cleaning and maintenance instructions, refer to table of contents.



The wipe test setup functions need to be performed prior to wipe testing. This includes setting efficiencies with the isotopes you will use, and setting up wipe locations.



CAUTION: Operation for: 100-240 VAC, 50/60 Hz.



ATTENTION: Opération pour : 100-240 VAC, 50/60 Hz.



WARNING: Only use approved power supplies.



AVERTISSEMENT: Utilisez Seulement des alimentations électriques approuvées.



CAUTION: To avoid risk of electric shock, this equipment must only be connected to supply mains with protective earth.



ATTENTION: Pour éviter le risque de choc électrique, cet équipement doit uniquement être connecté à un approvisionnement conduites avec la terre protectrice.



CAUTION: The plug is considered the method of disconnecting the product from mains power. Do not place the product in a position where the plug is not easily accessible.



ATTENTION: Le bouchon est considérée comme la méthode de déconnexion du produit d'alimentation. Ne placez pas le produit dans une position où le bouchon n'est pas facilement accessible.



CAUTION: The product is intended to remain in one location during operation.



ATTENTION: Le produit est voulu rester dans un emplacement pendant l'opération.

Unpacking Instructions

Shipping Cartons

The Atomlab Wipe Test Counter and its respective components are carefully packed in two cartons. One carton contains the display unit and accessories; the other carton contains the detector unit. Both are shipped in an overpack.



NOTE: Prior to removing any of the cartons from the shipping box, visually inspect the box and the inside packing for damage. If any damage is noted, do not unpack the contents. Notify the carrier immediately so that a claim can be made, if necessary, and contact your Biodex Medical Systems Sales Representative.



NOTE: Before deciding on a location to set up your Atomlab for operation, be sure to read Chapter 2 on installation. This chapter notes operating and environmental requirements, and offers several tips on choosing a location for your dose calibrator.

The Display Unit Carton

In addition to the Display Unit itself, this carton contains the Atomlab's Operation Manual, and all the necessary connection and power wires needed to run system.

The Detector Unit Carton



CAUTION: The carton labeled DETECTOR UNIT is very heavy, ~28 pounds. Severe damage to the unit may result if this carton is dropped. Remove the detector from the carton and carefully place it on the table or counter where you will set up and use your Atomlab unit. Make certain the tabletop will support a minimum of 300 pounds. We suggest that you place the carton on its side so that you can slide the Detector Unit out of the carton onto its base.



ATTENTION: Le carton étiqueté UNITÉ DE DÉTECTION est très lourd, ~28 livres. Cet appareil peut subir de sérieux dommages s'ii est échappé. Retirez le détecteur de son carton et utiliserez le avec prudence sur la table ou le computoir où vous installerez et utiliserez l'unité Atomlab. Assurezvous que la table supportera un minimum de 300 livres. Nous suggérons que vous placiez le carton sur son côté afin que vous puissiez faire glisser L'UNITÉ DE DÉTECTION du carton à sa base. Dans la chambre du calibrateur vous devriez trouver un manchon protecteur.

Save the Packing Material



Do not discard the packing materials, cartons or shipping boxes

This material was designed especially for the safe shipment of your Atomlab Wipe Test Counter. You will need them to return any of the Atomlab components in the future for updates, calibration or repair.

Atomlab Wipe Test Counter Warranty

1. Instrumentation

- A. This equipment and its accessories are warranted by BIODEX MEDICAL SYSTEMS, INC., against defects in materials and workmanship for a period of two years from the date of shipment from BIODEX MEDICAL SYSTEMS, INC. During the warranty period, BIODEX MEDICAL SYSTEMS, INC. will in its sole discretion, repair, recalibrate or replace the equipment found to have such defect, at no charge to the customer.
 - EXCEPT AS STATED ABOVE, THERE ARE NO WARRANTIES, EXPRESSED OR IMPLIED, INCLUDING WITHOUT LIMITATION WARRANTIES OR MERCHANTABILITY OR FITNESS FOR USE. BIODEX DOES NOT ASSUME LIABILITY FOR INCIDENTAL, CONSEQUENTIAL OR INDIRECT DAMAGES INCLUDING LOSS OF USE, SALES, PROFITS OR BUSINESS INTERRUPTION.
- B. This warranty <u>does not</u> apply if the product, as determined by BIODEX MEDICAL SYSTEMS, INC., is defective due to abuse, misuse, modification or service performed by other than a BIODEX MEDICAL SYSTEMS, INC. authorized repair and calibration facility. Misuse and abuse include, but are not limited to, subjecting limits and allowing the equipment to become contaminated by radioactive materials.
- C. In order to obtain warranty repair service, the equipment must be returned freight pre-paid to one of our facilities. The Return Material Authorization (R.M.A. #) should be included, along with a statement of the problem. Equipment will be returned transportation prepaid.

2. Calibration

- A. Instruments are warranted to be within their specified accuracy at the time of shipment. If a question arises and BIODEX MEDICAL SYSTEMS, INC. determines that the initial calibration is in error, the instrument will be recalibrated at no charge.
- B. Mechanical products are warranted to meet written specifications and tolerances at the time of shipment.
- C. The return policy is as stated in paragraph 1.C.

3. Warranty is non transferable.

4. Non-Warranty Service

- A. Repairs and/or replacements not covered by this warranty may be performed by BIODEX MEDICAL SYSTEMS, INC. at a factory authorized service location. Estimates of repair charges may be requested, however, a charge for estimate preparation may apply if the repair is later not authorized by the customer.
- B. The cost of transportation into and out of the service location will be the responsibility of the customer.

Service Procedure

If you think you have a service problem, take the following action.

- 1. Check to see that the problem occurs more than once.
- 2. Check the instruction manual and operations procedure.
- 3. Check the instruction manual Troubleshooting Guide.

If you still think you have a service problem, call BIODEX MEDICAL SYSTEMS, INC., Service Department at (800) 224-6339 (Int'l 631-924-9000).

Keep yourself and the phone next to the equipment.

- 1. Service will ask you for a brief description of the problem. We will ask specific questions about the malfunction that occurred. This diagnostic process may take a few minutes, so call us when you have time to spare.
- 2. After taking the information, we will advise on the action we will take.
- 3. Sometimes service personnel must consult with engineering and it may take time to get back to you. Be sure to let the service representative know your schedule so that we can call at a convenient time.
- 4. The return call may be from a person other than whom you first reported the problem to.
- 5. After analyzing the problem, we will decide if the unit must be returned to us for repair, or replacement parts will be sent.
- 6. If unit must be returned, it will be given a Return Material Authorization (R.M.A. #) number by us. Pack the system in the carton that it was originally shipped in, or pack it safely and securely to avoid shipping damage. It is the customer's responsibility for any damage that occurs during shipping.
- 7. Non-warranty/non-service contract charges for repair are as follows:
 - a. Materials

_

b. Time Service

+

c. Shipping Charges

Contact Information

Biodex Medical Systems, Inc.

20 Ramsey Road, Shirley, New York, 11967-4704

Tel: 800-224-6339 (Int'l 631-924-9000),

Fax: 631-924-9241

Email: info@biodex.com, www.biodex.com

1. Introduction

Intended Use

The Atomlab Wipe Test Counter is intended to measure the activity of a radioactive wipe. This measurement may be for the purposes of determining if a surface has been decontaminated with radiation.

Indications for Use

The Atomlab Wipe Test counter is used in nuclear medicine departments, clinics and nuclear pharmacies to measure contamination on a wipe.

The Biodex Atomlab Wipe Test Counter combines a LCD touch-screen with a 2x2 sodium iodide drilled well crystal integral line detector. The detector is housed in a lead shield with ½ inch of lead shielding. There is an optional ½ inch additional shielding that can be placed onto the well. The well detector has a 64 channel multi-channel analyzer built into the base of the well detector. The system is designed to allow the user to quickly and simply perform their required daily and weekly wipe tests for their department.

The Atomlab Wipe Test Counter is designed to use a Cs-137 Rod Source to perform the daily automatic calibration function. To use the Biodex Atomlab Wipe Test Counter there are initial setup functions that need to be performed and then the operator only has to do a daily calibration and a daily background check and they can easily count their wipes. The easy-to-use display can sit on a counter top or be mounted to the wall.

The Atomlab Wipe Test Counter has a full spectrum energy range of 0 to 800 keV, which covers the normal isotopes used in Nuclear Medicine. The Atomlab Wipe Test Counter uses one channel to accumulate any counts over 800 keV, allowing the user to know if there is a contaminate with a high energy over 800 keV.

When performing a wipe test the unit counts and displays a full spectrum count of 0 to 800 keV. From this full spectrum the Atomlab Wipe Test Counter displays the user set wide window and calculates the net counts in the wide window and the net dpm's in the wide window.

The Atomlab Wipe Test Counter allows the user the option of looking at just a wide window or the wide window plus the isotopes chosen for that location. The user creates the list of locations that they want to wipe and this list is stored in memory in the display. Each location can be customized to include results for specific isotopes and what type of wipe it is; restricted area, unrestricted, sealed source or package.

When a wipe is counted, only one count is required for determination of the results for the wide window and any isotopes associated with that location. Each isotope has a window associated with it and the system looks at each isotope's window and calculates the results for the specific windows from the one wide window count.

If a wipe count is above the wide window trigger level, the system notifies the operator that the trigger level has been exceeded. The system also shows if any individual isotopes that have been made available for this particular location are over the trigger and what the readings are for each individual isotope listed.

The user has the option to set the displayed results as cpm, dpm, microcuries, or bequerels. Different types of wipe tests can be set to show the results in different units of measurement. Each type of location has different trigger levels associated with the allowable level of contamination.

The Atomlab Wipe Test Counter is designed so that the wide window energy range that is used for the basic test results can be set by the user as well as what isotope efficiency they want to use for the calculation of the efficiency for the wide window. Typically, a low efficiency isotope is used for the wide window calculation. If the isotope with a low efficiency is used and the wipe passes the test, then isotopes that have a higher efficiency automatically would pass if they were the contaminates.

For the daily operation of the Atomlab Wipe Test Counter the user would first place the Cesium Rod into the well, press the button to automatically perform the calibration and after calibration, remove the source and perform a background measurement. Once the background measurement is completed and saved, the unit goes to the wipe test program. The count wipe can be depressed and the system will automatically do a wide window count with no location selected. If the user selects one of the locations and then presses count wipe, the system counts the wipe and does all the determinations that are required for the test. The Atomlab Wipe Test Counter allows the user to print their test results.



NOTE: The user can setup the system so the Daily Calibration is also Constancy. You must use the same source in the same Geometry every time the Constancy is performed.

2. Installation

Operating Requirements

Prior to installing your Atomlab Wipe Test Counter, plan a layout for your unit that will ensure it is convenient for measuring radionuclide wipes and will not be subject to radiation exposure due to proximity of high activity sources.



NOTE: Be sure to always place your wipe sample into a test tube before placing it into the detector. This will prevent contamination.

Work Surface

Choose a table or other counter which is free of vibration, does not wobble, and will easily support 300 pounds.

Suggested dimensions of the table top are:

- · 30 in. deep
- · 48 in. wide
- · 36 in. high

Physical Location and Environment

Frequently, Atomlab Wipe Test Counters are located in areas called hot labs in which there is a wet sink with plumbing. Do not locate your Wipe Test Counter on a table or other counter which can become wet or is subject to splashing or spraying.

Avoid areas which have drafts caused by heating or air conditioners, or are in direct sunlight. Electronics work best when constant temperature is maintained.

The temperature range is from 10 to 30° C, and the relative humidity range from 0 to 90%.

Choose a location for your Wipe Test Counter which is not frequently used by other personnel.

In general, make sure your work area is clean, dry, and dust free.

Avoid locating your Atomlab Wipe Test Counter near a radioactive materials storage area. The .5-inch lead shield around the detector shields it from changes in radiation levels from diagnostic energy radionuclides (i.e., Tc-99m); however, the high energy radiation from sources such as Cs-137, F-18 and Co-60 will easily penetrate the shield and change the background radiation level. The lower the ambient radioactivity, the less background activity for which the Atomlab Wipe Test Counter must compensate, and, the greater the accuracy and reliability of the readings. There is an additional .5-inch lead shield that can be added, bringing the total shielding to one inch.

Positioning

After you have chosen a suitable location for your Atomlab Wipe Test Counter and familiarized yourself with its components, position the various units. Make sure the Detector and Display Units have been positioned to where they will not have to be moved prior to connecting the cables.

Environmental Operating Conditions

Temperature: 10 to 30°C

Humidity: 0 to 90% rh, non-condensing

For optimum performance, the Atomlab Wipe Test Counter should be operated in a normal laboratory environment where the temperature and humidity are maintained for normal human comfort and the ambient radiation level is low and constant.

Environmental Shipping and Stowage Conditions

Temperature: 0 to 40°C

Humidity: 0 to 90% rh, non-condensing

For optimum performance, the Atomlab 500 should be operated in a normal laboratory environment where the temperature and humidity are maintained for normal human comfort and the ambient radiation level is low and constant.

Power Requirements

- · Choose a power source with a socket which mates securely with the power plug provided.
- · Verify that the power line is properly grounded.
- · Do not choose an outlet that has a wall switch control.



WARNING: Before inserting or removing connectors, turn the display power OFF.



AVERTISSEMENT: Avant le fait d'insérer ou le fait d'enlever des connecteurs, éteignez le pouvoir d'étalage.

This system uses an XP Power Supply for Medical use, model #PDM60US15, or the alternate ICC Nexergy (PEI Genesis) model MWA065015A-11A (modified).

Line Voltage

100 to 240 VAC, auto selectable by the power supply (1.5 - 0.75 amps).

Line Frequency

50/60 Hz.

Cable Connections

(See Figures 2.1 and 2.2.)

Connecting the Atomlab Wipe Test Counter cables is a simple process. One end of each cable matches only to the appropriate jack on the back of the display.

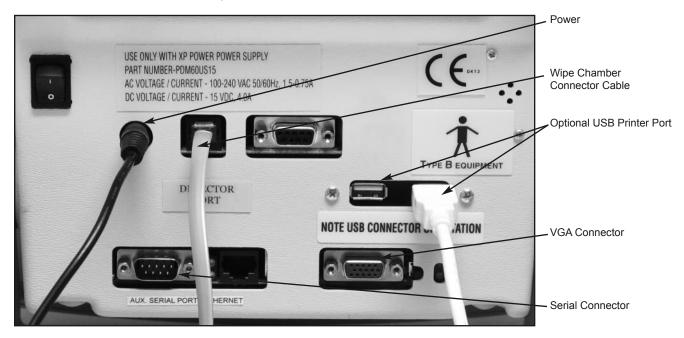


Figure 2.1. Atomlab Wipe Test Counter display cable connections.

- 1. Rotate the detector unit to access the connector on the base of the detector.
- 2. Insert one end of the RJ12 detector cable into the mating detector port.
- 3. Rotate the detector unit to its normal position so that the detector jack is facing away from the work area.
- 4. Rotate the display unit to access the connection ports located on the display back panel.
- 5. Insert the free end of the detector cable into the mating display port.
- 6. If you would like to connect a computer to the Atomlab Wipe Test Counter, attach a Null Modem RS-232 cable with a female DB9 connector to the computer serial port on the display and then attach the opposite end of the cable to the appropriate port on the computer.
- 7. Insert the round end of the power supply or power pack into the power port on the display
- 8. Insert the female end of the power cord into the black, rectangular power pack. The system is now ready for power-up.

NOTE: As long as the Atomlab Wipe Test Counter is plugged in and power turned ON, the system will be functioning. Depending on the Backlight Time setting, the display screen will eventually turn OFF. Simply touch the screen to reactivate.

NOTE: If more than two USB ports are needed, a USB expansion hub (not included) can be used to provide additional USB ports.

NOTE: The display can sit on the counter top or be mounted on the wall. Use the holes in the base to mount to the wall.



Figure 2.2. The Atomlab Wipe Test Counter connected to a well counter and printer.

Power Up and System Test

(See Figures 2.3 and 2.4.)

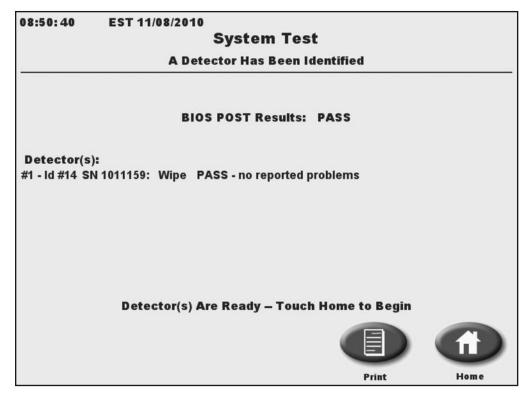


Figure 2.3. The Atomlab Wipe Test Counter System Test results.

Once the system cables are fully connected, plug the power supply into a wall socket. Toggle the Power Switch, located on back of the display, to the "ON" (I) position. The green power ON LED on the display will light and the system automatically performs a system-test as part of the power-up process.

The system test includes the following checks:

Display

· BIOS Post Results

Detectors

- · Communication with all detectors
- · I.D. number and serial number
- · Detector status

During the power-up system test, a screen is displayed showing the components and detector status. If all items pass, "Pass" is displayed next to each item at the completion of the test. Should any aspect of the self test fail, "Fail" is displayed, along with an accompanying error code and optional description of the problem.

Once the system check is completed, touch <Print> to generate a printout of the system test results and/or touch <Home> to advance to the Home Screen.

NOTE: The Atomlab Wipe Test Counter can be left on continually. If turned OFF, power ON at least 10 minutes prior to operation.

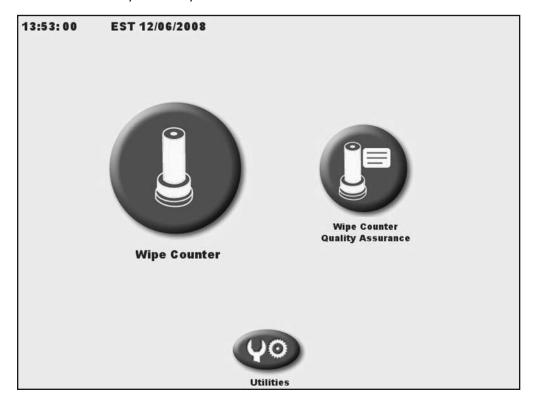


Figure 2.4. The Home Page screen.

Maintenance

General Cleaning Instructions

As required, wipe down the exterior of the unit using a soft rag slightly dampened with alcohol. Use neutral detergent or isopropyl alcohol on a clean soft cloth to clean the touch panel surface. Do not use any kind of chemical solvent, acidic or alkali solution. If the well gets contaminated, use alcohol to clean it.

Quality Assurance Testing

To properly maintain your Atomlab Wipe Test Counter, the following quality assurance procedures should be performed:

1. During daily calibration, the system automatically performs and displays the results for Full Width Half Max (FWHM). The Full Width Half Max results should be less than 10%.

NOTE: If you have the system set up to perform Calibration/Constancy, you must use the same Cs-137 source in the same Geometry every time you are performing the Calibration/Constancy. Constancy takes the calibrations and tracks the variance from test to test.

- 2. Perform the Chi-Square test as per your facility requirements.
- 3. Perform the Minimum Detectable Activity (MDA) wipe quality assurance program as required by your regulations. See Chapter 6: Wipe Test Counter Quality Assurance.

3. Getting Started

Basic Key Functions

Easy to read and intuitive to use, the Atomlab Wipe Test Counter touch screen display prompts users to advance effortlessly and logically though the Utilities, Wipe Test Counter and Wipe Test Counter Quality Assurance programs. The following basic prompts appear throughout the program and, unless otherwise noted, always perform the following functions:

- · <Home> returns the system to the Home screen.
- · <>> advances one field or screen.
- · <<>> or <Back> returns to the previous screen.
- < <>> scrolls up through the current list. (On some screens, holding on this button increases scroll speed.)
- <▼> scrolls down through the current list. (On some screens, holding on this button decreases scroll speed.)
- · <Clear> erases all user entries to fields on the current screen.
- · <Cancel> or <X> cancels any entry and/or returns the user to the previous screen.
- · <Enter> or <Yes> confirms any entry and/or advances to the next screen.
- · <Print> Prints the currently displayed screen or report.
- · <Shift> Toggles keypad entry between upper and lower case.
- · <BS> moves the cursor one space back, deleting the previous keystroke, on any keypad.
- · <Measure Bkgrnd> begins a minimum 30-second background measurement.

NOTE: To select or highlight any option, simply touch the desired field on the display. The field or option will now be highlighted.

NOTE: When a well detector (075-594) is added to the Atomlab 500, the display automatically recognizes the additional detector and shows the Home screen for both the dose calibrator and wipe test counter.

Password Protection

There are several program setups that require the use of a password for access to make changes. The default password is: 123, followed by <Enter>.

If you need to change the password, contact **Biodex Customer Service at 800-224-6339.**

Before Wipe Testing

Before performing any wipe testing, you should perform a High Voltage (H.V.) adjustment after installation. The system requires a new H.V. adjustment every 30 days. See Chapter 6 for information on performing a high voltage adjustment.

You'll also need to complete a daily calibration and background measurement before performing a wipe test to ensure proper operation and accurate readings. If these operations have not yet been performed, or have not been performed within the past 24 hours, the system will automatically prompt for their completion. Both the calibration and background procedure are explained in Chapter 6: Wipe Test Counter Quality Assurance.

Before performing your first wipe test using the Atomlab Wipe Test Counter, you'll need to enter some basic information, including setting up the wipe locations and efficiencies for each isotope to be wiped. This information must be entered before the system will allow a wipe to proceed, and is presented in Chapter 4, Wipe Test Counter Configuration (Setup).

4. Wipe Counter Utilities

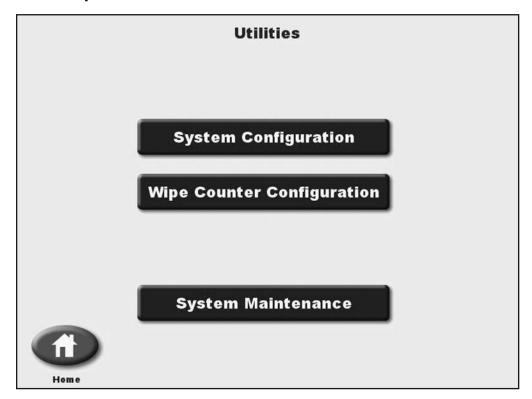


Figure 4.1. The Wipe Utilities screen.

Wipe Test Utilities

The Wipe Counter Utilities Program provides access to the System Configuration, Wipe Counter Configuration and System Maintenance functions. System Configuration applications are detailed in Chapter 7 and System Maintenance is covered in Chapter 8. Wipe Counter Configuration is explained on page 4-2.

Wipe Counter Configuration

(See Figures 4.1 and 4.2.)

The Wipe Utilities Program allows the technologist or physicist to configure the Atomlab Wipe Test Counter for maximum efficiency. It is suggested that you review and enter the appropriate information into each configuration (setup) category before attempting an initial wipe test. Use the Wipe Utilities Program to access the Wipe Counter Configuration screen and then enter or edit the various parameters for wipe testing including:

- · Isotope List
- · Wipe Location Setup
- · Wide Window Isotope
- · Preferences
- · Constancy Setup

To access the Utilities menu, touch <Utilities> on the Home page. The Wipe Utilities Menu is now displayed. Touch <Wipe Counter Configuration> to access the Wipe Counter Configuration screen. Touch the desired option to select.



NOTE: Before proceeding with an initial wipe test, the wipe areas and efficiencies for each individual isotope to be wiped must be defined. You must, therefore, select the isotopes you wish to use and count or input their efficiencies before performing any wipe testing. The wide window uses Cs-137 for the default isotope.

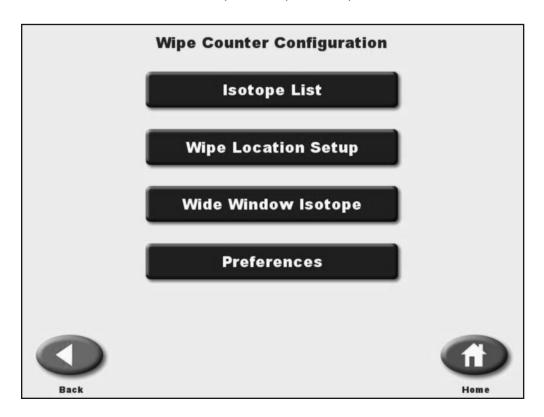


Figure 4.2. The Wipe Counter Configuration screen using a calibration and not a constancy.



Figure 4.3. The Wipe Counter Configuration menu using Constancy for Calibration.

Isotope List

(See Figures 4.4. and 4.5.)

The password protected Isotope List for Wipes allows the technologist to select isotopes as well as add, remove or edit custom isotopes. It also allows editing of isotope settings.

To Access The Isotope List For Wipes Screen:

- 1. From the Utilities Menu, touch <Wipe Counter Configuration>. The Wipe Counter Configuration screen should now be displayed.
- 2. Touch <lsotope List> and then enter your password (123 is the default password). Touch <Enter> to advance to the Isotope List For Wipes screen.

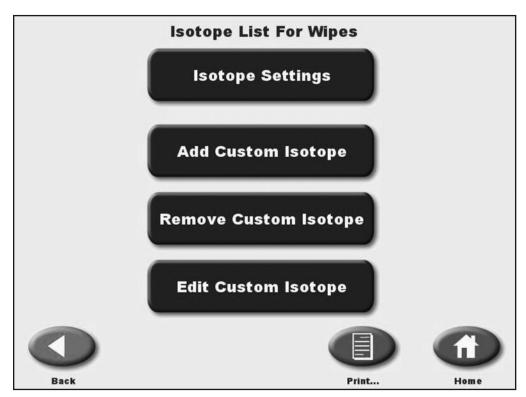


Figure 4.4. The Isotope List For Wipes screen.



Figure 4.5. The Enter Password screen.

Isotope Settings

(See Figures 4.6 - 4.8.)

To Access The Isotope Settings Screen:

- 1. From the Home screen, select <Utilities>. The Utilities screen is now displayed.
- 2. Select <Wipe Counter Configuration>. The Wipe Counter Configuration screen is now displayed.
- 3. Select < lsotope List>.
- 4. At the Enter Password screen, key in your password (123 is the default). Select <Enter> to advance to the Isotope List For Wipes screen.
- 5. Select <lsotope Settings>. The Select Isotope Screen is now displayed with an alphabetical listing of isotopes. Custom isotopes will display first if you have added any to your wipe test counter.
- 6. Select the desired isotope from the Isotope List by touching to highlight the desired Isotope and select <Enter>. The Isotope Settings screen for the selected isotope is now displayed.

NOTE: The Isotope List for Wipe Screen allows the user to select isotopes for wipe testing, modify those isotopes, and add, remove or edit custom isotopes and their settings.

To Setup The Isotope Settings:

- 1. At the Isotope Settings screen, highlight the desired isotope. If necessary, use the <▲> or <▼> icons to scroll through the isotope list.
- 2. With the desired isotope highlighted, select <Enter>. The Isotope Settings screen is now displayed. This screen displays the following isotope information:

System Defined Parameters, (cannot be changed by the user):

- · Isotope name and if the isotope is factory or custom defined
- · Half-life in minutes, hours or years
- · ROI upper and lower levels for factory defined isotopes
- · Package Regulatory Level in DPM

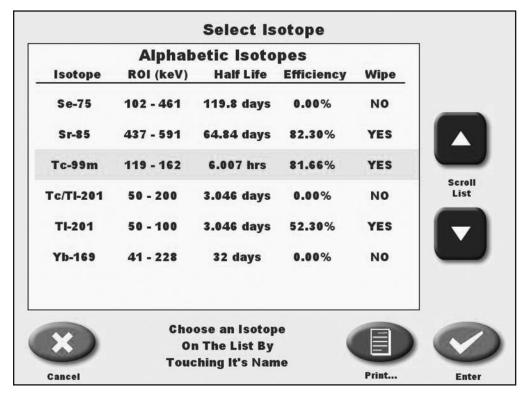


Figure 4.6. The Select Isotope screen.

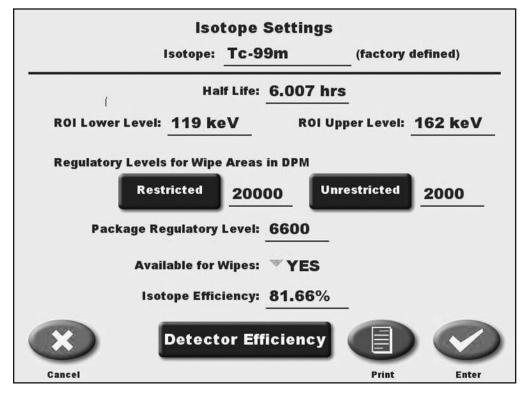


Figure 4.7. The Isotope Settings screen.

User Defined Parameters, (can be changed by the user):

- · Regulatory Levels for Wipe Areas in DPM
- · Available for Wipes: Yes or No
- · Isotope Efficiency percentage
- · Detector Efficiency: Allows setting the isotope efficiencies
- · Geometric Efficiency: Allows setting the geometric efficiencies

NOTE: System efficiency is detector efficiency multiplied by geometric efficiency.

At the bottom of the Isotope Settings screen:

- \cdot <X> cancels all information entered and returns to the Isotope List For Wipes screen.
- · <Print> prints out the selected Wipe Isotope information.
- · <Enter> selects the highlighted isotope and advances to the Isotope settings screen.

Regulatory Levels

(See Figure 4.8.)

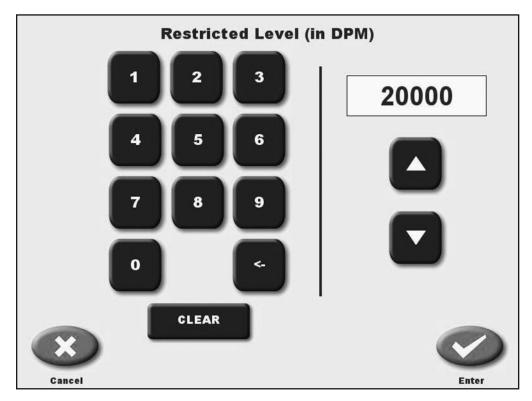


Figure 4.8. Keypad entry allows the user to set the appropriate Restricted Level (in DPM).

That Atomlab Wipe Test Counter includes factory preset regulatory trigger levels to NRC regulations. The user can change these trigger levels, from the Isotope Settings screen, if desired.

- 1. To change the Regulatory Levels for Wipe Areas touch <Restricted>. The Keypad screen is now displayed.
- 2. Enter the appropriate value in Disintegrations Per Minute (DPMs) on the Keypad screen. Touch <Enter> to confirm and return to the Isotope Settings screen. Use the same procedure to set the <Unrestricted> regulatory level.

NOTE: The Package regulatory level is fixed and cannot be changed. It is set for a 300 cm² wipe with a 6600 DPM limit.

3. Select <▼>, <Yes> or <No>, next to Available For Wipes, to change the available for wipes setting. To have an isotope available for wipe testing, set it to <Yes>.



NOTE: Isotope efficiency must be established before an isotope can be made available for wipe.

Detector Efficiency

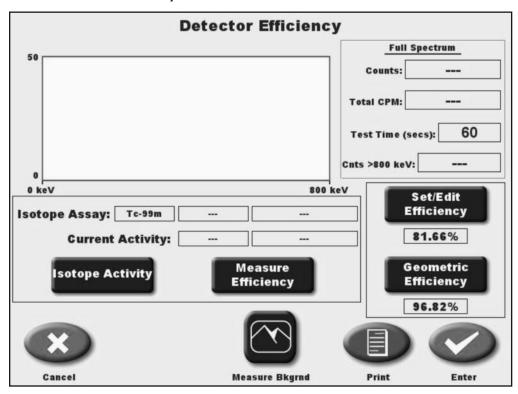


Figure 4.9. The Detector Efficiency screen. Before counting a sample, touch the <Measure Bkgrnd> button to advance to the Background Count screen and perform a background count.



NOTE: You must set an efficiency level for all isotopes that will be used for wipe testing. The wide window efficiency must also be set before counting wipes.

NOTE: Isotope Efficiency

The total efficiency for an isotope is made up of the geometric efficiency multiplied by the detector efficiency for a specific isotope. (See Appendix A, Isotope Efficiency Calculation for more detail.)

Detector Efficiency is selected from the Isotope Settings screen. If you are on the Isotope Setting Screen, skip to Step 7.

To Access The Detector Efficiency Screen:

- 1. From the Home screen, select <Utilities>. The Utilities screen is now displayed.
- 2. Select <Wipe Counter Configuration>. The Wipe Test Counter Configuration screen is now displayed.
- 3. Select <lsotope List>.
- 4. At the Enter Password screen, key in your password (123 is the default). Select <Enter> to advance to the Isotope List For Wipes screen.
- 5. Select <lsotope Settings>. The Select Isotope screen is now displayed.
- 6. Select the desired isotope from the Isotope List and select <Enter>. The Isotope Settings screen for the selected isotope is now displayed.
- 7. Select < Detector Efficiency>. The Detector Efficiency screen is now displayed.

The Detector Efficiency screen allows the technologist to use a user-created sample or count a known reference standard to determine the isotope efficiency or use a predetermined factory efficiency by entering the number. You can also set the detector geometric efficiency.

Geometric Efficiency

(See Figure 4.10.)

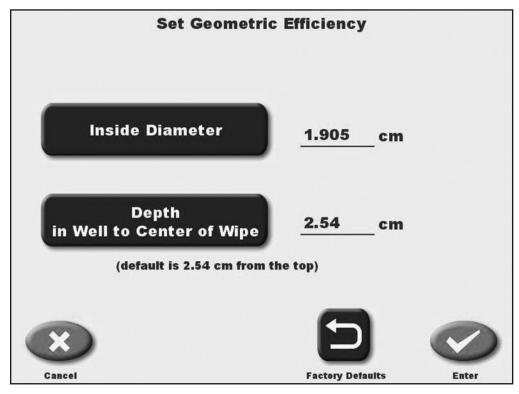


Figure 4.10. The Set Geometric Efficiency screen allows the user to manually enter geometric efficiency values or simply select the factory defaults.

Setting Geometric Efficiency

- 1. At the Detector Efficiency screen, touch <Geometric Efficiencies>. The Set Geometric Efficiency screen is displayed.
- 2. The inside diameter of the detector is preset for the Atomlab Wipe Test Counter at 1.905 cm.
- 3. The location of the center of the wipe is set by selecting <Depth in well to center of wipe>. When the keypad is displayed, enter the depth to the center of the wipe from the top of the crystal. The depth is preset at 2.54 cm from the top of the crystal.

NOTE: The crystal depth is 1.44" (3.07 cm).

- 4. Touch <Enter> to set the geometric efficiency and return to the Detector Efficiency screen.
- 5. If desired, use <Factory Defaults> to reset the "inside diameter and depth in well to center of wipe" to the factory defaults.

Using The Factory Installed Detector Efficiencies

(See Figure 4.9.)

- 1. At the Isotope Settings screen, touch <Detector Efficiency>. The Detector Efficiency screen is now displayed.
- 2. Touch <Set/Edit Efficiency>. The Set Edit Efficiency screen is now displayed. Touch <Factory Defaults>. The factory default for the selected isotope is now displayed.

NOTE: The factory default is an analytically determined number or a previously determined value from users. Not all isotopes have a default value.

3. Touch <Enter> to return to the Detector Efficiency screen with the factory default for the selected isotope now displayed.

Manually Entering Detector Efficiency

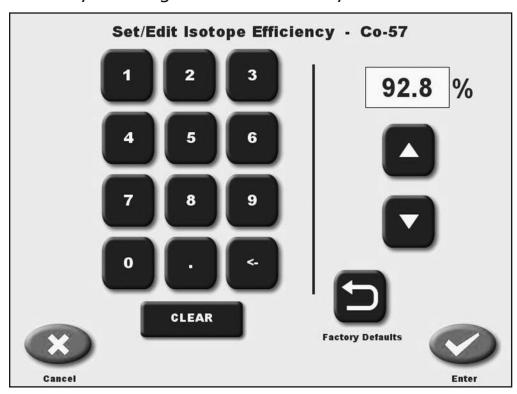


Figure 4.11. The Set/Edit Efficiencies screen allows the user to enter or delete efficiencies, or to use an analytically determined detector efficiency.

- 1. At the Isotope Settings screen, touch <Detector Efficiency>. The Detector Efficiency screen is now displayed.
- 2. Touch <Set/Edit Efficiency>. The Set Edit Isotope Efficiency screen is now displayed.
- 3. Using the keypad, enter the desired efficiencies.
- 4. Touch <Enter> and repeat step 3.

NOTE: To reset the efficiency to zero, on the Set/Edit Efficiency screen, type 0 and then press <Enter>.

To Count and Set The Detector Efficiency of a Known Standard: (See Figure 4.12 and 4.13)

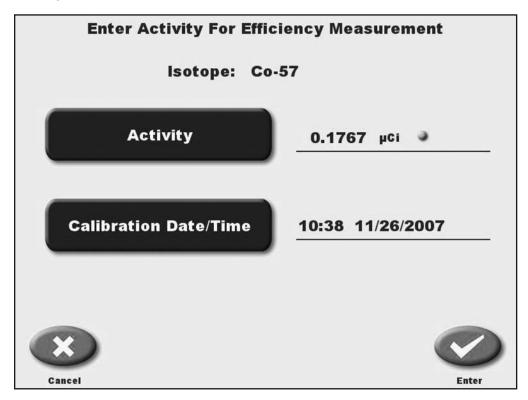
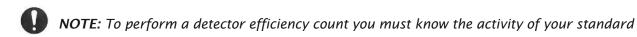


Figure 4.12. The Enter Activity For Measurement screen.

- 1. At the Isotope Settings screen, touch <Detector Efficiency>. The Detector Efficiency screen is now displayed.
- 2. Touch <Isotope Activity>. The Enter Activity For Efficiency Measurement screen is now displayed.



- 3. Touch <Activity> and then enter the calibration activity using the keypad. Touch <Enter> to record the new activity.
- 4. Toggle between mCi or μCi by touching the appropriate value next to the activity entered.

NOTE: To count a sample to determine the efficiency, the activity should be less than 0.1 μ Ci.

NOTE: See Appendix A for details on creating a standard to use for performing an efficiency.

- 5. Touch <Calibration Date/Time>. The Enter Calibration Date screen is now displayed. Touch to highlight any parameter to change. Use the <♠> and <▼> keys to scroll to the appropriate values. Touch <Enter> to return to the Enter Activity For Efficiency Measurement screen.
- 6. Touch <Enter> to return to the Detector Efficiency screen with the new isotope activity information selected.

7. Touch <Measure Efficiency> to advance to the Detector Efficiency screen.

NOTE: The count time for efficiency is the time set in Wipe Counter "preferences" for the <Wipe Count Time>. The efficiency count time should be a minimum of 30 seconds when calculating efficiency.

NOTE: The system will require a daily calibration and background count done each day to proceed.

- 8. Place the efficiency source into the detector and touch <Start>. The system will begin a 30-second countdown as it measures the isotope ROI. The calculated efficiency is now displayed in the Set/Edit Efficiency window.
- 9. Touch <Print> to print the Detector Efficiency screen, <Cancel> to return to the Isotope Setting screen without saving the New Detector Effciency, or <Enter> to return to save and return to the Isotope Setting Screen.

NOTE: When the detector efficiency is set the system automatically makes the isotope available for wipe.

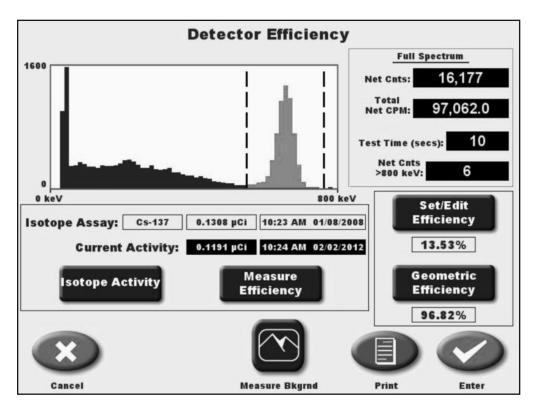


Figure 4.13. The Set/Edit Efficiency window with calculated efficiency displayed.

Make An Isotope Available Or Unavailable For Wipe (See Figure 4.14.)

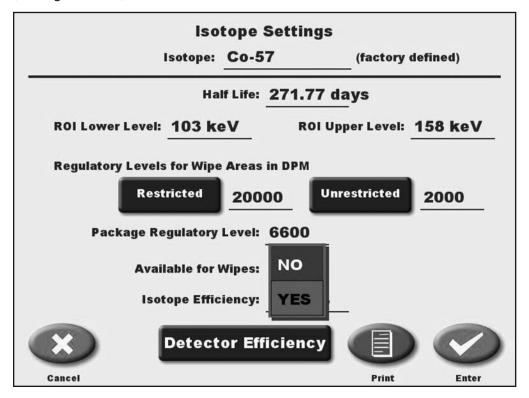


Figure 4.14. The Isotope Settings screen. Toggle < Yes> or < No> to make available or unavailable for wipe.

- 1. To make the selected isotope available or unavailable for wipe, at the Isotope Settings screen, touch to toggle <Yes> or <No> next to the Available For Wipe prompt.
- **NOTE:** You must have a detector efficiency for the selected isotope listed, plus a geometric efficiency, to make an isotope available for wipe.
- 2. Touch <Enter> to return to the Isotope List For Wipes screen.

Add Custom Isotope

(See Figure 4.15.)

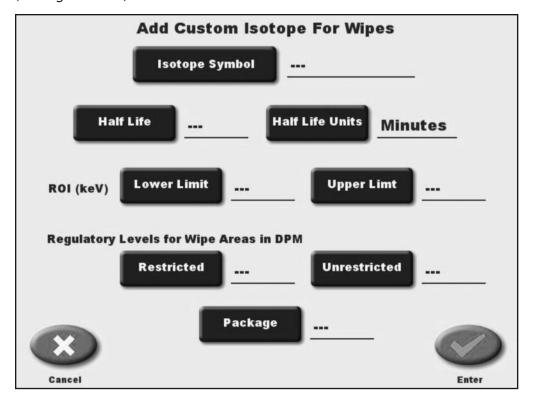


Figure 4.15. The Add Custom Isotope For Wipe screen.

The Add Custom Isotope screen allows users to add a new user defined isotope for wipe testing to the isotope list. All of the following parameters must be entered to add the isotope:

- · Isotope Symbol
- · Half Life
- · Half Life Units (seconds, minutes, hours, days, years)
- · ROI Lower Limit
- · ROI Upper Limit
- · Regulatory Levels (restricted and unrestricted)
- · Package Levels

To Add A Custom Isotope For Wipes:

NOTE: If you are at the Isotope List for Wipe Screen, go to Step 5.

- 1. From the Home screen, select <Utilities>. The Utilities screen is now displayed.
- 2. Select <Wipe Counter Configuration>. The Wipe Test Counter Configuration screen is now displayed.
- 3. Select <lsotope List>.
- 4. At the Enter Password screen, key in your password (123 is the default). Select <Enter> to advance to the Isotope List For Wipes screen.
- 5. Select <Add Custom Isotope>. The Add Isotope For Wipes screen is now displayed.
- 6. Touch to highlight any field and then enter the value via the keypad. Touch <Enter> after each entry to return to the Add Isotope For Wipes screen. For Half-Life Units, touch to toggle between seconds, minutes, hours, days, years.
- 7. Once you have filled out the entire Add Isotope for Wipes screen, touch <Enter> to advance to the Add Isotope to List screen. Touch <Yes> to add the isotope, or <X> to cancel and return to the Isotopes List for Wipes screen.



NOTE: You must enter a value for each item.

8. Once the new isotope has been added, the system will prompt completion of an efficiency measurement and return to the Isotope List For Wipes screen. Select <Isotope Settings> and return to the Isotope List, where you can select the new isotope to perform an efficiency measurement, touch <Enter> and perform the detector efficiency as previously described.

Remove Custom Isotope

To remove a custom isotope from the isotopes list:

- 1. From the Wipe Counter Configuration screen, touch < Isotope List>.
- 2. Enter your password and touch <Enter>. The Isotope List For Wipes screen is now displayed.
- 3. Touch <Remove Custom Isotope>. The Remove Isotope screen is now displayed
- 4. Touch to highlight the isotope to remove.
- 5. Touch <Yes> to remove the isotope.
- 6. The system returns to the Isotope List For Wipes screen. The isotope is now removed from the Isotope List.

NOTE: You can only remove the custom isotope you have added to the Isotope List. You cannot remove the factory list of isotopes.

Edit Custom Isotope

(See Figure 4.16.)

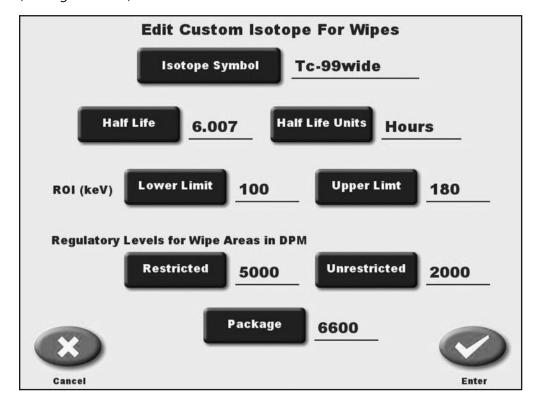


Figure 4.16. The Edit Custom Isotope for a specific added custom isotope.

To Edit An Added Custom Isotope From The Isotopes List:

NOTE: You can only edit the custom isotopes you added to the new isotope list. To edit the factory list of isotopes, use the Isotope Settings screen.

NOTE: If you are at the Isotope List for Wipes Screen, go to Step 5.

- 1. From the Home screen, select <Utilities>. The Utilities screen is now displayed.
- 2. Select <Wipe Counter Configuration>. The Wipe Test Counter Configuration screen is now displayed.
- 3. Select < lsotope List>.
- 4. At the Enter Password screen, key in your password (123 is the default). Select <Enter> to advance to the Isotope List For Wipes screen.
- 5. Select <Edit Custom Isotope >. The Edit Isotope screen is now displayed.
- 6. Select the isotope to edit from the Isotope List and select <Enter>. The Edit Isotope For Wipes screen for the selected isotope is now displayed.
- 7. Touch to highlight any field, then enter the value via the keypad. Touch <Enter> after each edit to return to the Edit Isotope For Wipes screen. For Half-Life Units, touch to toggle between seconds, minutes, hours, days, years.
- 8. Once all edits are complete, touch <Enter> to save the edits and return to the Isotope List for Wipes screen.

Wipe Location Setup (See Figure 4.17 and 4.18.)

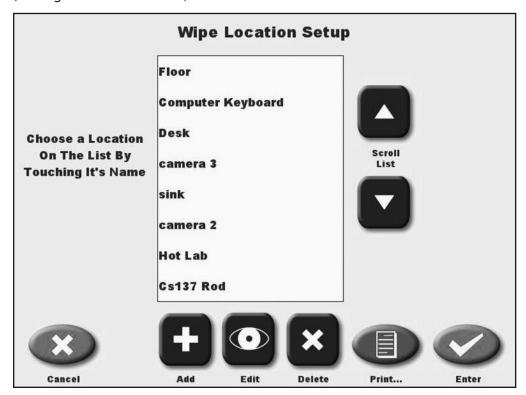


Figure 4.17. The Wipe Location Setup screen.



Figure 4.18. The Wipe Location Detail screen.

The Wipe Location Setup screen allows the user to define individual wipe locations and select isotopes specific for each location defined.

To Access The Wipe Location Setup screen:

- 1. From the Home screen, select <Utilities>. The Utilities screen is now displayed.
- 2. Select <Wipe Test Counter Configuration>. The Wipe Test Counter Configuration screen is now displayed.
- 3. Select <Wipe Location Setup>.
- 4. At the Enter Password screen, key in your password (123 is the default). Select <Enter> to advance to the Wipe Location Setup screen. From this screen you can <Add>, <Edit> or <Delete> a wipe location.

To Add A Wipe Location:

1. At the Wipe Location Setup screen, select <Add>. The Add a Wipe Location screen is now displayed.

NOTE: The system automatically repeats the isotopes added to the previous wipe location created. This eliminates the need to add each isotope when creating a new location. You can add or remove isotopes from any wipe location you are adding. This does not affect other locations.

- 2. Select <Location> and enter the location description via the keypad. Select <Enter> to return to the Add a Wipe Location screen. The new location is now displayed.
- 3. Select <Type> to display the Type menu. Select the appropriate Wipe Type setting: Restricted, Unrestricted, Sealed Source or Package.
- 4. Select <Trigger Level> value to display the Trigger Level menu. Select the appropriate Trigger Level. This is a percentage of the regulatory value for each isotope.
- 5. To Add Location Isotopes to the new wipe location, select <Add>. The Select Isotope List is now displayed. Highlight the isotope to be added and select <Enter>. The Add a Wipe Location screen is now displayed with the new isotope listed in the Location Isotopes window. Add each isotope one at a time.
- 6. To Delete an isotope from the Location Isotopes window, highlight the isotope to delete and select <Delete>. The isotope is immediately deleted from the Location Isotopes window.
- 7. Select <Enter> to save the new wipe location. The Wipe Location Setup screen is now displayed with the new isotope added to the Wipe Location Setup Location List.
- 8. Select <Enter> to return to the Wipe Counter Configuration screen.

NOTE: The order in which you enter a wipe location is the order the location will appear in Wipe Location Setup List. A suggestion would be to enter Daily Wipes and Packages, then Weekly Wipes. Sealed Source wipes are automatically placed below all wipes at the bottom of the list since they are infrequently wiped.

Wide Window Isotope

(See Figure 4.19.)

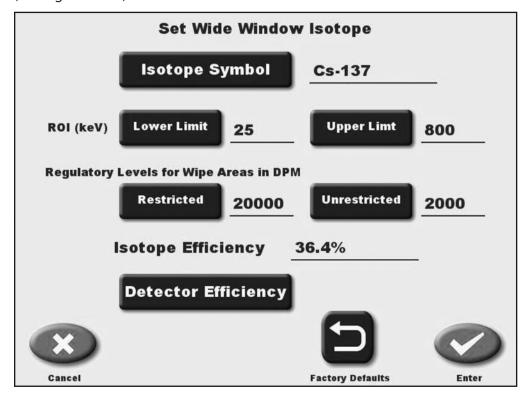


Figure 4.19. The Set Wide Window Isotope screen.

The Wide Window Isotope screen allows the user to set up a wide window for the wide window wipe test.



NOTE: You must set up the wide window to perform wipe testing.

The user can select factory default settings, or customize the settings.

To Access the Wide Window Isotope Screen and Set Wide Window Isotope Default settings:

- 1. From the Wipe Test Counter Configuration screen, select <Wide Window Isotope>.
- 2. Enter your password and select <Enter>. The Set Wide Window Isotope screen is now displayed.
- 3. Select <Factory Default>. The default settings will be automatically entered in the appropriate fields.
- 4. Select <Enter> to return to the Wipe Test Counter Configuration screen.

NOTE: Cs-137 is used as the factory default isotope because it has a low efficiency compared to other isotopes used in nuclear medicine departments.

To Custom Set A Wide Window Isotope:

- 1. From the Wipe Test Counter Configuration screen, select <Wide Window Isotope>.
- 2. Enter your password and select <Enter>. The Set Wide Window Isotope screen is now displayed.
- 3. Touch <Isotope Symbol> and select the isotope to set as a wide window from the Isotope List. Select <Enter> to return to the Set Wide Window Isotope with the isotope selected.

NOTE: Only isotopes available for wipe testing can be set as the wide window isotope.

4. If desired, select <Factory Defaults> for all values. The system sets the factory defaults. Select <Enter> to return to the Wipe Test Counter Configuration screen.

NOTE: The factory default for the wide window is for Cs-137. See Appendix A for efficiencies for some isotopes with a wide window of 25 to 800 keV. You must manually enter these efficiencies

NOTE: The counting time for efficiency is the time set in Wipe Counter "Preferences" as the <Wipe Count Time>. The counting time should be a minimum of 30 seconds when calculating efficiency.

- 5. If not using the Cs-137 factory defaults, select <Lower Limit> and enter the new ROI Lower Level value. Select <Enter> to save and return to the Set Wide Window Isotope screen.
- 6. Select <Upper Limit> and enter the new ROI Upper Level value. Select <Enter> to save and return to the Set Wide Window Isotope screen.
- 7. Select <Restricted> and enter the new Restricted Level value in DPM. Select <Enter> to save and return to the Set Wide Window Isotope screen.
- 8. Select <Unrestricted> and enter the new Unrestricted Level value. Select <Enter> to save and return to the Set Wide Window Isotope screen.
- 9. Perform the <Detector Efficiency> by entering the <Isotope Activity> and then <Measure Efficiency>.

NOTE: There are no factory default values for wide windows on the Set/Edit Detector Efficiency screen. You can look up values in Appendix A and enter them in the Set/Edit screen.

Preferences

(See Figure 4.20.)

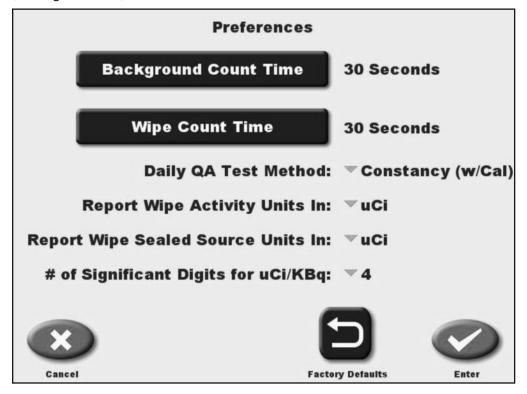


Figure 4.20. The Preferences screen allows uses to set background measurement time and wipe count time, along with units for wipe report activity, sealed source and the number of significant digits for mCi or KBq. Factory defaults can also be selected for these parameters.

To Access The Preferences Screen:

- 1. From the Home screen, select <Utilities>. The Utilities screen is now displayed.
- 2. Select <Wipe Counter Configuration>. The Wipe Test Counter Configuration screen is now displayed.
- 3. Select < Preferences>.
- 4. At the Enter Password screen, key in your password (123 is the default). Select <Enter> to advance to the Preferences screen.

The Preferences screen allows users to set several system parameters including:

- · Background Count Time
- · Wipe Count Time
- · Daily QA Test Method (constancy/calibration or just calibration)
- · Report Wipe Activity Units In: (DPM, mCi/Bg or Cnts)
- · Report Wipe Sealed Source Units In: (DPM, mCi/Bq or Cnts)
- # of Significant Digits for mCi/KBq: (2 5)

NOTE: If your system is set up for curies, then mCi is displayed. If set up for Becquerels, then Bq is displayed.

The user can set any parameter listed, or choose to use the factory default settings.

To Select Preference Default Settings:

- 1. At the Preferences screen, select <Factory Defaults>. The default settings will be automatically entered in the appropriate fields.
- 2. Select <Enter> to return to the Wipe Test Counter Configuration screen.

To Set Custom Preferences:

- 1. From the Wipe Test Counter Configuration screen, select < Preferences >. The Preferences screen is now displayed.
- 2. Select <Background Count Time> and then enter the appropriate time value via the keypad. Select <Enter> to save the new value and return to the Preferences screen.

NOTE: Minimum background count time is 30 seconds. Maximum is 1200 seconds.

NOTE: Minimum wipe count time is 5 seconds. Maximum is 1200 seconds.

NOTE: It is recommended to use a minimum of 30 seconds for <Wipe Count Time>.

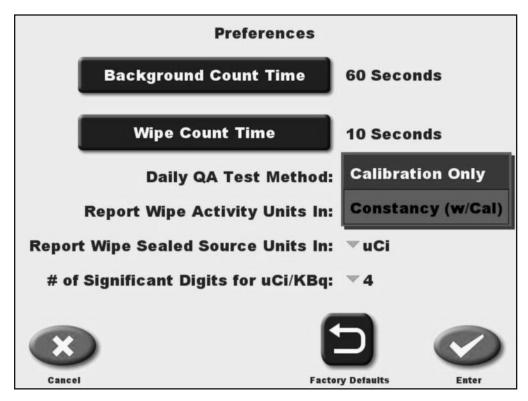


Figure 4.21. The Select Daily QA Test Method screen.

- 3. Select <Wipe Count Time> and then enter the appropriate time value via the keypad. Select <Enter> to save the new value and return to the Preferences screen.
- 4. Select <Daily QA Test Method>. Toggle between Calibration Only and Constancy (w/cal).
- 5. Select the value for Report Wipe Activity Units. Toggle between DPM, mCi/Bq or Cnts.
- 6. Select the value for Report Wipe Sealed Souce Units. Select DPM, mCi/Bq or Cnts.
- 7. Select # of Significant Digits for mCi/KBq. Select from 2 to 5 digits.
- 8. Once all preferences have been set, select <Enter> to save and return to the Wipe Counter Configuration screen.

Constancy Setup

(See Figure 4.22 and 4.23)

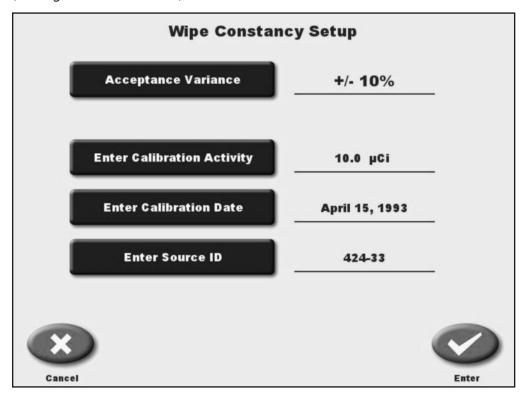


Figure 4.22. The Wipe Constancy Setup screen.

The Wipe Constancy Setup screen allows users to enter an acceptance variance value, calibration Activity, calibration date and Source I.D.

To Set Wipe Constancy Values:

- 1. From the Wipe Counter Configuration screen, select <Constancy Setup>. The Wipe Constancy Setup screen is displayed.
- 2. Touch to select <Acceptance Variance>, then use the keypad or scroll keys to enter the appropriate value. Touch <Enter> to confirm and return to the Wipe Constancy Setup screen.
- 3. Touch to select <Enter Calibration Activity>, then use the keypad or scroll keys to enter the appropriate value. Touch <Enter> to confirm and return to the Wipe Constancy Setup screen.

- 4. Touch to highlight <Enter Calibration Date>. Touch to highlight each field and use the <▲> and <▼> keys to enter the date desired. Touch <Enter> to confirm and return to the Wipe Constancy Setup screen.
- 5. Touch to highlight <Enter Source I.D.>. Use the keypad to enter the Source I.D. #. Touch <Enter> to confirm and return to the Wipe Constancy Setup screen.
- 6. When all entries are set, touch <Enter> to return to the Wipe Constancy Setup screen.

				Constan	-				
Biodex Model 086-332 Serial # 1008002p Detector Serial # 9020011 Printed: 02/02/2012 12:07 PM									
			Printe	d: 02/02/2012	12:07 PM				
Print Range: All									
	Source: Cs	s-137 ID:	424-33 A	ctivity: 10.0 uCi	Date: April 15, 1	993			
Date	Detector SN	Counts	СРМ	FWHM Peak Bir	Time (secs)	Var+/- 10%	Technologist		
1/10/12 2:38 PM	8070005	197192	592308.0	5.8% 52	20	-0.5%	css		
1/10/12 2:31 PM	8070005	198105	595035.0	5.8% 52	20	-4.8%	css		
2/27/11 6:44 AM	2007002	208152	625332.0	7.7% 52	20	0.2%	css		
2/26/11 7:34 PM	2007002 2007002	207815 204754	624177.0 615072.0	7.7% 52 7.8% 51	20 20	1.5% -1.5%	CSS tom jones		
2/15/11 7:39 AM 2/13/11 6:02 AM	2007002	204754	624315.0	7.7% 52	20	-5.1%	CSS		
2/11/11 6:11 PM	2007002	219041	657903.0	7.8% 51	20	6.3%	CSS		
2/11/11 5:57 PM	2007002	206070	619035.0	7.7% 52	20	-9.3%	CSS		
2/08/11 9:10 AM	2007002	227216	682479.0	7.7% 52	20	8.2%	css		
2/04/11 4:13 AM	2007002	210013	630909.0	7.7% 52	20	5.6%	css		
2/01/11 7:04 PM	2007002	198918	597495.0	7.7% 52	20	-3.7%	css		
2/01/11 6:59 PM	2007002	206549	620436.0	5.8% 52	20	3.8%	css		
2/01/11 10:28 AM	2007002	198926	597558.0	7.7% 52	20	0.1%	css		
1/30/11 10:26 AM	2007002	198771	597105.0	7.7% 52	20	-4.7%	css		
1/29/11 10:15 AM	2007002	208495	626271.0	7.7% 52	20	0.4%	css		
1/15/11 10:05 AM	2007002	207608	623679.0	7.7% 52	20	-0.1%	css		
1/12/11 10:03 AM	2007002	207896	624483.0	7.7% 52	20	-0.1%	CSS		
1/10/11 10:01 AM	2007002	208112	625101.0 s-137 ID:	7.7% 52 Activity:	20 Date:		css		
1/07/11 9:56 AM	2007002	208719	626916.0	7.7% 52	20	-0.4%	css		
1/07/11 9:55 AM	2007002	209555	629466.0	7.7% 52	20	0.1%	CSS		
1/04/11 10:54 AM	2007002	209377	628965.0	7.7% 52	20	0.3%	css		
1/02/11 10:52 AM	2007002	208852	627390.0	7.7% 52	20		css		

Figure 4.23. A Wipe Constancy Data printed report.

5. Performing A Wipe Test

The wipe test is used to determine the removable contamination level of wipes taken in the designated areas of a department. A total of 50 wipe locations may be identified and counted. When wipe counting is completed, a report of the wipe test results can be printed out with each test identified by the location and wipe results.

Prior to performing a wipe test using the Atomlab Wipe Test Counter, you'll need to configure your wipe test system as explained in Chapter 4, Wipe Test Counter Configuration (Setup), and perform a daily calibration and background measurement to ensure proper operation and accurate readings. If these operations have not yet been performed, or have not been performed in the past 24 hours, the system will automatically prompt for their completion.

To begin the wipe test procedure, select <Wipe Counter> from the Home screen. If you have not already performed a daily calibration and background measurement, the system will prompt you to calibrate before proceeding.

Daily Calibration/Constancy

(See Figures 5.1 - 5.3)

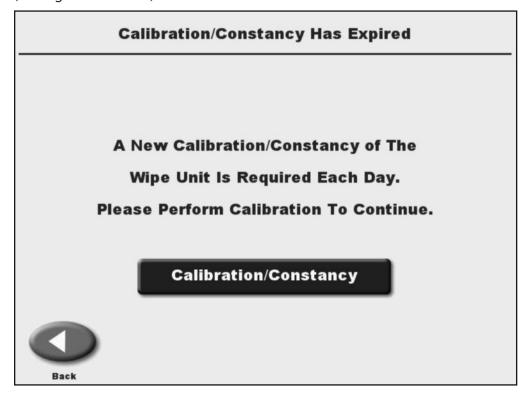


Figure 5.1. The Daily Calibration/Constancy Needed screen.

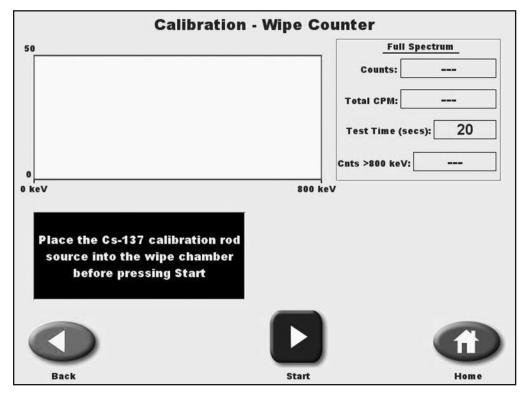


Figure 5.2. The Atomlab Wipe Test Counter Daily Calibration screen.

A daily calibration must be completed whenever the system power has been turned OFF, or once every 24 hours. If you have not performed a daily calibration, the system will prompt you to do so when you try to perform a wipe test.

The Constancy function is a form of calibration that uses the same source and source orientation to provide repeatable counts for the calibration. The system calculates the variation between daily calibration counts to determine the variation in counts as the daily constancy calculation. The counts should be within a certain variation to have an acceptable constancy level.

To perform a daily calibration when one has not been done within the last 24 hours:

- 1. Touch < Daily Calibration >. The Calibration Wipe Counter screen is displayed.
- 2. Ensure the area is clear of contamination.
- 3. Place the Cs-137 Rod Source into the wipe detector and touch <Start>. The system will begin a 20-second countdown. Select <Abort> to abort the calibration at any time.

NOTE: It is recommended to use 0.1 μ Ci Cs-137 Rod Source



NOTE: When the calibration count is completed, you must select a technologist to save the calibration.

4. If you need to enter or change the technologist, touch <Technologist>. The Technologist List will be displayed.

To enter a new technologist:

- Touch <Add Technologist>.
- Use the keypad to enter the technologist name and touch <Enter>. The new technologist name will be added to the Technologist list.
- Touch to highlight the technologist name desired from the Technologist List and then touch <Enter>. The system returns to the Calibration - Wipe Test Counter screen with the new technologist selected.

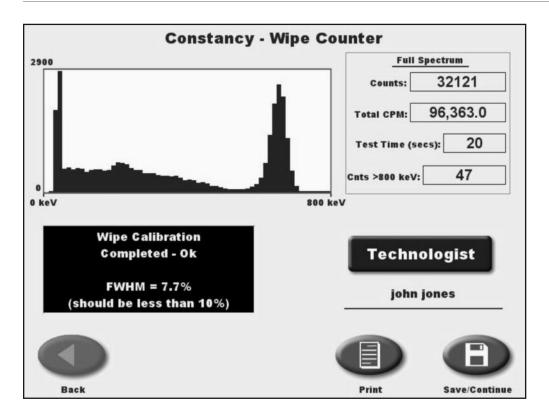


Figure 5.3. The Atomlab Wipe Test Counter Daily Calibration Results screen.

- 5. Touch <Print> to print out a copy of the new calibration, if desired.
- 6. Touch <Save/Continue> to record and save the daily calibration. The display advances to the Background Wipe Test Counter screen.

NOTE: If the system will not allow completion of daily calibration, you may need to first perform a high voltage test as described in Chapter 6: Wipe Counter Quality Assurance.

Background Measurement

(See Figure 5.3.)

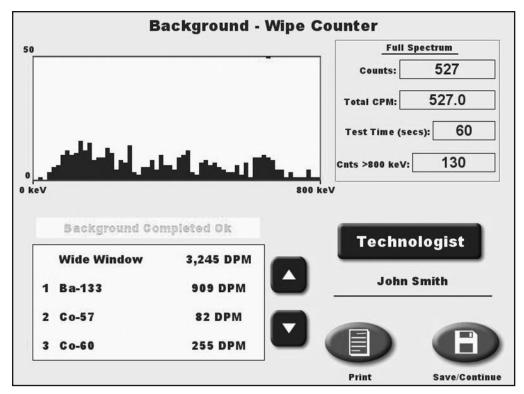


Figure 5.4. The Background Wipe Test Counter screen.

Like daily calibration, a background measurement must be taken on a daily basis, once every 24 hours, or any time the system has been turned OFF. If you have not performed a background check within these parameters, the system will prompt you to do so before allowing a wipe test to proceed.

To perform a Background Measurement:

- 1. Ensure the area is clear of background contamination and the detector is free of radioactive sources.
- 2. At the Background Wipe Test Counter screen, touch <Start>. The system begins a minimum 30-second background measurement. When complete, the display will note that Background is completed and OK, or that the background test has failed.

NOTE: The background count time is set in the Wipe Counter Configuration Preferences screen.

- 3. If you need to enter or change the technologist, touch <Technologist>. The Technologist List will be displayed. To enter a new technologist:
- Touch <Add Technologist>.
- Use the keypad to enter the technologist name and touch <Enter>. The new technologist name will be added to the Technologist list.
- Touch to highlight the technologist name desired from the Technologist List and then touch <Enter>. The system returns to the Background - Wipe Test Counter screen with the new technologist selected.
- 4. Touch <Print> to print out a copy of the background results, if desired.
- 5. Touch <Save/Continue> to record and save the background results and advance to the Wipe Test Counter screen.

Wipe Test Procedure

(See Figures 5.5 - 5.9.)

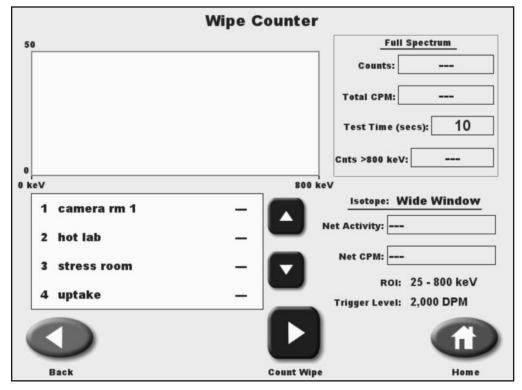


Figure 5.5. The Wipe Test Counter screen.

Having performed a daily calibration, background measurement and, if necessary, high voltage adjustment, a wipe test can be performed using the following basic procedure.

NOTE: Wipe test can be performed for specific locations or, if you do not select a location, the wipe is done for a wide window only.

To Perform A Wipe Test:

- 1. Ensure the wipe detector is clear of radioactive sources.
- 2. At the Home menu, select <Wipe Counter>. The Wipe Counter screen will be displayed.
- 3. Highlight the Wipe Location desired by touching the location. If necessary, use the <▲> or <▼> icons to scroll though the list.
- 4. Place the wipe into the test tube and place into the wipe detector. Select <Count Wipe>. The system will begin counting the wipe.
- 5. When the wipe count is complete, the system will display an acceptance or failure message. Full Spectrum Net Counts, Total Net CPM, Test Time (seconds) and Net Counts Over 800 keV will be displayed in the Full Spectrum window. Net Activity, Net CPM, ROI keV and Trigger Level will be displayed in the Isotope Window.

6. Data presented in the Isotope Window is for a Wide Window. To view data for any individual isotope turned ON within the selected location, highlight the isotope from the displayed isotope list by touching the isotope name. The data for that specific isotope will now be displayed in the Isotope Window. To return to the Wide Window display, touch the isotope name to remove the highlight from the selected isotope and return to the wide window.

NOTE: When the isotope is highlighted, the spectrum shows the ROI for the isotope and the isotope window section shows the ROI keV being displayed. You can print the spectrum with the isotope window displayed.

- 7. Select <Print/Save> to print out a wipe report or save the wipe test without printing, or <Discard> to discard this wipe test without saving and return to the Wipe Test Counter screen.
- **NOTE:** To print the spectrum, you must select <Print> before saving the wipe test. Once the wipe test has been saved, the spectrum will no longer be available.

NOTE: After printing, select <Back> and you can print again after selecting another isotope from the list.

- 8. If you elected to save/print this wipe test, the Wipe Print/Save screen should now be displayed.
- 9. Select <Technologist> to change the technologist, <Print> to generate an individual Wipe Test Report with spectrum, or <Save Data> to save the results without printing, and return to the Wipe Counter screen.

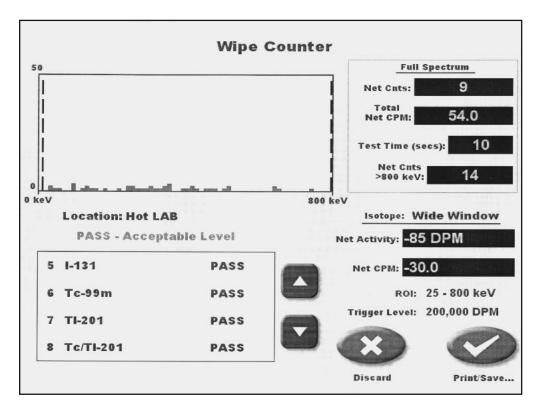


Figure 5.6. The Wipe Counter screen with an acceptable wide window spectrum displayed. You must print this screen before saving or the spectrum will be unavailable for printing.

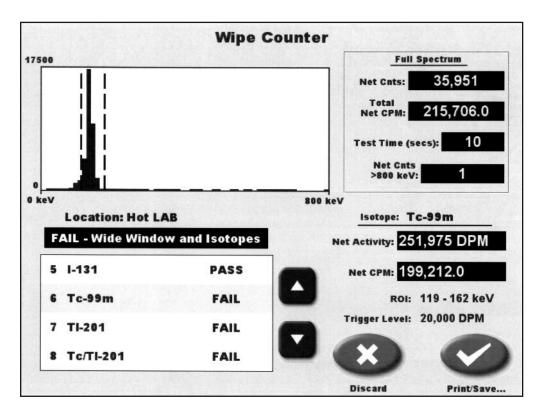


Figure 5.7. A Wipe Counter screen showing a wipe that failed with an individual isotope highlighted.

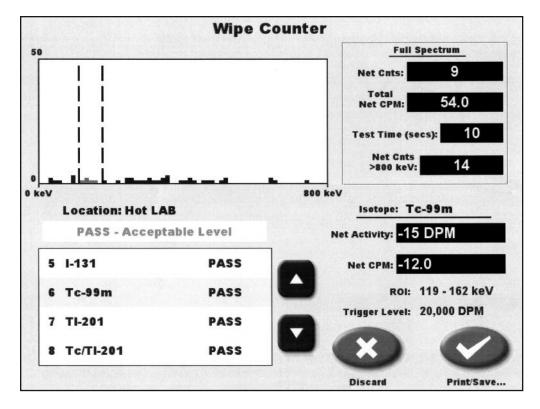


Figure 5.8. An acceptable Wipe Counter spectrum for an individual isotope turned ON for the region of interest.

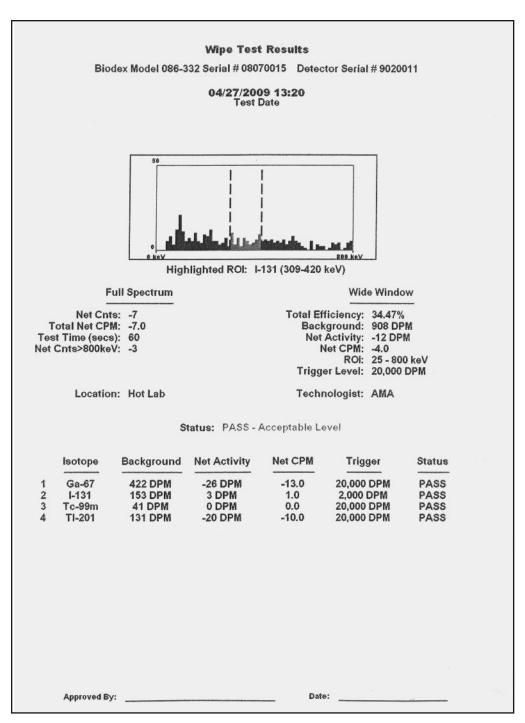


Figure 5.9. A printed, acceptable, Wipe Test Results report with spectrum.

6. Wipe Counter Quality Assurance

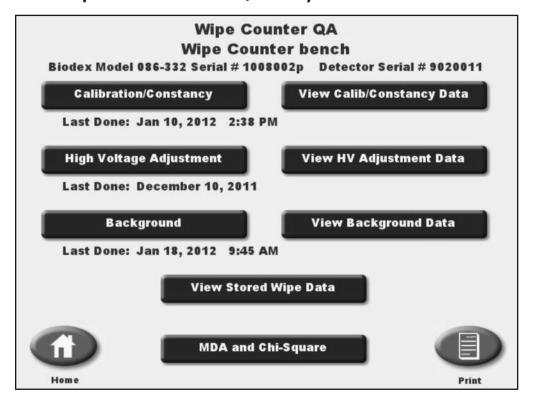


Figure 6.1. The Wipe Counter Quality Assurance screen.

The Wipe Test Counter Quality Assurance programs allow the user to perform and record a variety of system tests to assure the integrity of the readings and calculations.

To access the Wipe Test Counter Quality Assurance functions, at the Home screen select <Wipe Counter Quality Assurance>. The Wipe Test Counter QA screen should now be displayed.

From this screen you can select:

- · Calibration/Constancy
- · View Calibration/Constancy
- · High Voltage Adjustment
- · View High Voltage Adjustment Data
- · Background
- · View Background Data
- · View Stored Wipe Data
- · MDA and Chi-Square

Calibration/Constancy

(See Figure 6.2)

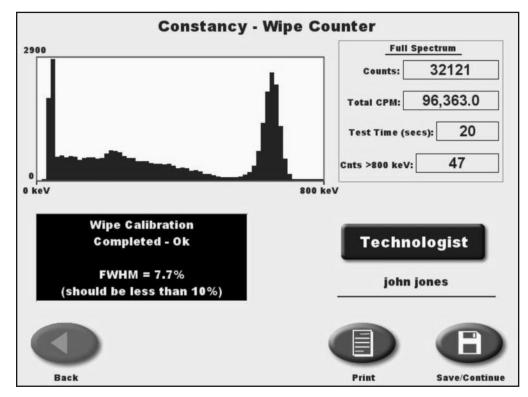


Figure 6.2. The Calibration Wipe Test Counter screen.

A calibration must be completed whenever the system power has been turned OFF, or once every 24 hours. At power up, the system automatically prompts for a daily calibration. It will also prompt for daily calibration before allowing a wipe test if calibration has not been performed within the past 24 hours. For calibration at any other time, access calibration from the Wipe Test Counter Quality Assurance screen.

The Constancy function is a form of calibration that uses the same source and source orientation to provide repeatable counts for the calibration. The system calculates the variation between daily calibration counts to determine the variation in counts as the daily constancy calculation. The counts should be within a certain variation to have an acceptable constancy level.

To Perform A Calibration/Constancy:

- 1. At the Home Menu, touch <Wipe Counter Quality Assurance>. The Wipe Counter QA screen is displayed.
- 2. Select <Calibration/Constancy>. The Calibration Wipe Test Counter screen is displayed.
- 3. Ensure the area is clear of contamination.
- 4. Place the Cs-137 Rod Source into the wipe detector and touch <Start>. The system will begin a 20-second countdown.

NOTE: It is recommended to use 0.1 µCi Cs-137 Rod Source.

5. If you need to enter or change the technologist, touch <Technologist>. The Technologist List will be displayed.

To enter a new technologist:

- · Touch <Add Technologist>.
- Use the keypad to enter the technologist name and touch <Enter>. The new technologist name will be added to the Technologist list.
- Touch to highlight the technologist name desired from the Technologist List and then touch <Enter>. The system returns to the Calibration - Wipe Test Counter screen with the new technologist selected.
- 6. Touch <Print> to print out a copy of the current calibration, if desired.
- 7. Touch <Save/Continue> to record and save the daily calibration. The display returns to the Wipe Counter QA screen.

View Calibration/Constancy Data (See Figures 6.3 and 6.4.)

Stored Chi-Square	Report								
Biodex Model 086-332 Serial # 0608001		rial # 2007002							
02/05/2009 10:02 AM Measure Date									
Chi-Square Test Results Value: 6.56 Status: PASS Sample # Counts	Chi-Square 0.99 0.95 0.90 0.50 0.10 0.05 0.01	Value 2.09 3.33 4.17 (Lower Limit) 8.34 14.68 (Upper Limit) 16.92 21.67							
Technologist: karen Jefferson	Date								
Approved By:	Date:								

Figure 6.3. The Wipe Constancy Data screen.

The View Calibration/Constancy Data function allows users to set the viewing and printing time frame options (today, prior to, from/to, from or all calibrations performed). It displays the calibration date, time, status, counts, FWHM, peak bin, time (seconds) and technologist, along with the Biodex Wipe Test Counter model number, display serial number and detector serial number. Users can choose to view the entire list of calibrations, or select specific dates to review. Unwanted calibrations can also be deleted from the Calibration/Constancy Data list.

To View All Calibration/Constancy Data:

1. At the Wipe Test Counter QA screen, select <View Calibration/Constancy Data>. The Wipe Constancy Data screen is now displayed with a listing of all calibrations performed in the selected time frame option. Use the <▲> or <▼> icons to scroll though the list if you desire to see calibrations recorded on earlier or later dates.

To Delete Any Listed Calibration/Constancy:

- 1. At the View Calibration/Constancy Data screen, highlight the date to delete and then select <Delete>.
- 2. Select <OK> to delete the entry and return to the Calibration/Constancy Data screen. The deleted calibration entry is deleted from the calibration/constancy list.

To Change Viewing Options:

If desired, the calibration/constancy list can be altered to show all calibrations, today's calibrations, calibrations prior to a specific date, calibration between two specific dates, or Calibrations/Constancys from (after) a selected date.

- 1. At the View Calibration/Constancy Data screen, select <Options> to advance to the Calibration/Constancy Data Options screen.
- 2. Select <Option> to toggle through the calibration/constancy list viewing options. To view "All" calibrations or "Today's" calibrations only, toggle to the desired choice and select <Enter>. The View Calibration/Constancy Data screen is now displayed with the appropriate calibration list.
- 3. To view calibrations prior to a selected date, between selected dates, or from a selected date, use <Option> to toggle to the desired setting.
- 4. Select the appropriate <Date> field and then enter the desired date or date range using the <▲> or <▼> icons. Select <Enter> after completing each field to record the new date.
- 5. Once the date fields are completed, select <Enter> to return to the Calibration/Constancy Data screen calibrations for the selected date(s) now displayed.
- 6. Select <Print> at any time to print the Calibration/Constancy Data screen.

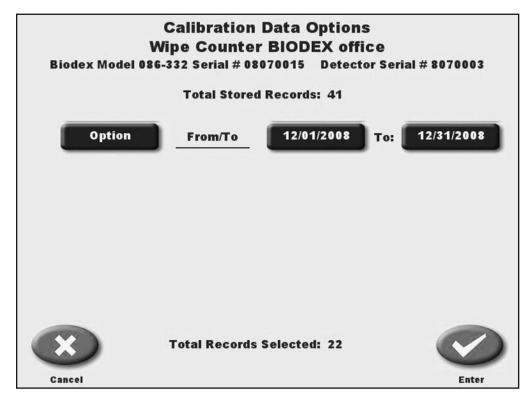


Figure 6.4. The Calibration/Constancy Data Options screen.

High Voltage Adjustment

(See Figure 6.5.)

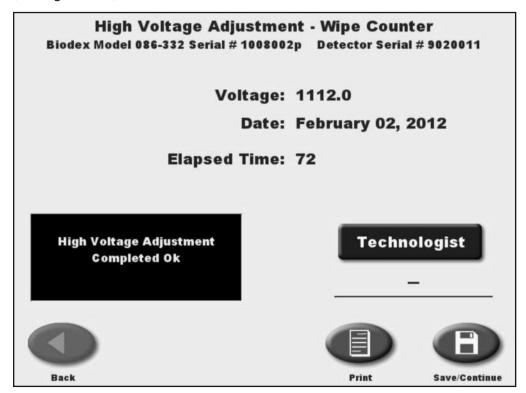


Figure 6.5. The High Voltage Results screen.

High Voltage Adjustment should be performed the very first time the system is used, if the system is to be used in a new environment, or in the instance where a substantial change has been made, i.e., when using a new tube. High Voltage is automatically prompted if you attempt to perform a wipe without having completed a High Voltage Adjustment within the last 30 days, or if there is a bin shift of more than 2 bins. Because background can change with high voltage, you must perform a new background test every time you do a high voltage test.

NOTE: When a High Voltage Adjustment is performed on a detector, the pervious background for that detector is zeroed. You must perform a new background for a detector following a High Voltage Adjustment. You can do a high-voltage adjustment for the detector at any time.

To Perform A High Voltage Adjustment:

1. At the Home Menu, touch <Wipe Counter Quality Assurance>. The Wipe Counter QA screen is displayed.

NOTE: It is recommended to use 0.1 μ Ci Cs-137 Rod Source

- 2. Select <High Voltage Adjustment>. The High Voltage Adjustment screen is displayed. Results for the most recently completed high voltage adjustment, along with the date performed, are displayed.
- 3. Place the Cs-137 calibration rod source into the wipe detector and select <Start>. The system will begin counting. When counting is completed, a High Voltage Completed OK prompt will be displayed, along with the voltage, last done date, and elapsed time (seconds).
- 4. Select <Technologist>. The Technologist List will be displayed.



NOTE: You must select a technologist to save the high voltage adjustment.

To enter a new technologist:

- Touch <Add Technologist>.
- Use the keypad to enter the technologist name and touch <Enter>. The new technologist name will be added to the Technologist list.
- Touch to highlight the technologist name desired from the Technologist List and then touch <Enter>. The system returns to the High Voltage Adjustment screen with the new technologist selected.
- 5. Select <Print> to print out a copy of the current high voltage, if desired.
- 6. Select <Save/Continue> save the high voltage adjustment. The display returns to the Wipe Test Counter QA screen.

View High Voltage Adjustment Data (See Figure 6.6).

HV Adjustment Data									
Wipe Counter BIODEX office									
Biodex Mo	Serial #8	070003							
Date	Status	Voltage (V)	Peak Bin	Time (secs)	Technolo	gist			
01/12/09 14:04	Ok	1022.5	52	59	AMA				
1/06/09 14:25	Ok	1020.0	52	59	AMA				
12/02/08 08:55	Ok	1021.3	52	53	AMA				
11/21/08 13:56	Ok	1020.0	52	65	AMA				
11/01/08 08:10	Ok	1021.3	52	53	AMA				
	_				_				
		×		7][/					
Back	Options	Delete	E	arlier L	ater	Print			

Figure 6.6. The High Voltage Adjustment Data screen.

The View High Voltage Data function allows users to view all high voltage adjustments performed. It displays the high voltage date and times, status, voltage (V), peak bin, time (seconds) and technologist, along with the Biodex Wipe Test Counter model number, display serial number and detector serial number. Users can choose to view the entire list of high voltage adjustments, or select specific date ranges to review. Unwanted high voltage adjustments can also be deleted.

To View All High Voltage Adjustments:

1. At the Wipe Test Counter QA screen, select <View HV Adjustment Data>. The HV Adjustment Data screen is now displayed with a listing of all high voltage adjustments performed. Use the <▲> or <▼> icons to scroll though the list if you desire to see entries from earlier or later dates not displayed.

To Delete Any Listed High Voltage Adjustment:

- 1. At the HV Adjustment Data screen, highlight the date to delete and then select <Delete>.
- 2. Select <Yes> to delete the entry and return to the HV Adjustment Data screen. The deleted calibration entry is deleted from the High Voltage Adjustment list.

To Change Viewing Options:

If desired, the High Voltage Adjustment list can be altered to show all high voltage adjustments, today's high voltage adjustments, high voltage adjustments prior to a specific date, high voltage adjustments within a date range, or high voltage adjustments from (after) a selected date.

- 1. At the HV Adjustments screen, select <Option> to advance to the HV Adjustments Data Options screen.
- 2. Select <Option> to toggle through the HV viewing options. To view "All" HV Adjustments, or "Today's" HV Adjustments only, toggle to the desired choice and select <Enter>. The View HV Adjustments Data screen is now displayed with the appropriate HV list.
- 3. Select the appropriate <Date> field and then enter the desired date or date range using the <▲> or <▼> icons. Select <Enter> after completing each field to record the new date.
- 4. Once the date fields are completed, select <Enter> to return to the HV Adjustment Data screen with HV Adjustments for the selected date(s) now displayed.
- 5. Select <Print> at any time to print the HV Adjustment Data screen.

Background

(See Figure 6.7.)

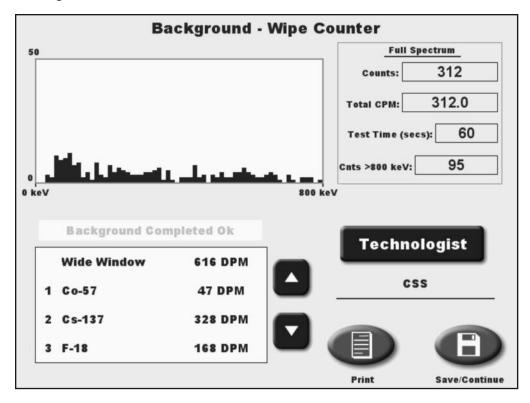


Figure 6.7. The Background Wipe Test Counter screen.

Like daily calibration, a background measurement must be taken on a daily basis, once every 24 hours, following a High Voltage set, or any time the system has been turned OFF. If you have not performed a background check within these parameters, the system will prompt you to do so before allowing a wipe test to proceed. To perform a background measurement at any other time, access Background from the Wipe Test Counter Quality Assurance screen as follows:

To Perform A Background Measurement:

1. Ensure the area is clear of background contamination and the detector is free of radioactive sources.

NOTE: To perform a background at any time, at the Wipe Test Counter QA screen, select <Background> to advance to the Background Wipe Test Counter screen.

2. At the Background – Wipe Test Counter screen, touch <Start>. The system begins a minimum 30-second background measurement. When complete, the display will note that Background is completed and OK.

NOTE: The user sets the desired background measurement time on the Utilities Wipe Counter Configuration Preferences screen.

- 3. If you need to enter or change the technologist, touch <Technologist>. The Technologist List will be displayed. To enter a new technologist:
- Touch <Add Technologist>.
- Use the keypad to enter the technologist name and touch <Enter>. The new technologist name will be added to the Technologist list.
- Touch to highlight the technologist name desired from the Technologist List and then touch <Enter>. The system returns to the Background - Wipe Test Counter screen with the new technologist selected.
- 4. Touch <Print> to print out a copy of the background results, if desired.
- 5. Touch <Save/Continue> to record and return to the Wipe Counter QA screen.

View Background Data (See Figures 6.8 - 6.11.)

		В	ackgro	und Da	ta					
Wipe Counter desk										
Biodex	Model 08	6-332 Sei	rial # 100	14002P	Detector S	erial#	2007002			
Date	Status	Counts C	nts>800ke	V Total CPM	Time(secs)	Techno	logist			
11/07/10 3:52	PM Ok	399	124	399.0	60	cs				
11/05/10 5:46	AM Ok	253	57	506.0	30	cs				
11/01/10 10:09	AM Ok	148	37	296.0	30	JR				
10/27/10 11:26	AM Ok	151	45	302.0	30	***************************************				
10/20/10 5:50	AM Ok	217	54	434.0	30	***************************************				
10/15/10 5:25	AM Ok	178	64	356.0	30	cs				
10/14/10 6:21	AM Ok	151	42	302.0	30	cs				
10/09/10 5:57	PM Ok	161	67	322.0	30	cs				
10/09/10 5:54	PM Ok	160	57	320.0	30	cs				
10/03/10 7:18	PM Ok	179	55	358.0	30	cs				
0					√]					
Back	Option	s View I	Data Do	elete E	arlier L	ater	Print			

Figure 6.8. The Background Data screen.



Figure 6.9. The Background Options Screen for Viewing and Printing.

The View Background function allows users to view all background measurements performed. It displays the wide window results showing time, date, status, counts over 800 keV, total CPM, counting time (seconds) and technologist, along with the Biodex Wipe Test Counter model number, display serial number and detector serial number. Users can choose to view the entire list of background measurements, or select specific dates to review.

If the user presses <Options> the Stored Wipe Data Options Wipe Counter screen is displayed. The <Option> button allows the user to display the following data selections: All, Today, Prior to, From/To and From. The printed format can also be printed in a <Summary Report> or <Detail Report> for the wipe range specified.

If desired, background <View Data> can be displayed. Unwanted background measurements can also be deleted.

If a closer examination of background data is required or you desire to view the specific isotope detail, highlight the wipe you wish to view and then select <View Data>. You can then return to the wipe detail by selecting <Print>.

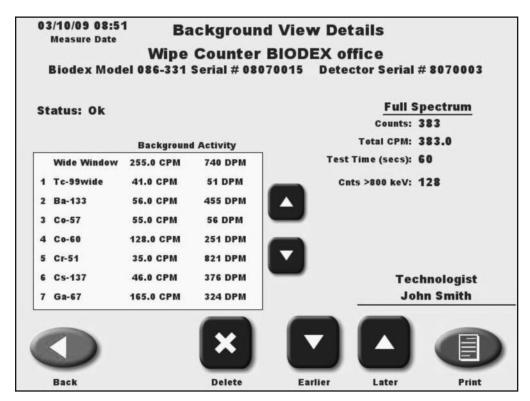


Figure 6.10. The Background View Details screen.

To View All Background Measurements:

At the Wipe Test Counter QA screen, select <View Background Data>. The Background Data screen is now displayed with a listing of the background measurements performed. Use the <▲> or <▼> icons to scroll though the list if you desire to see entries from earlier or later dates. Use <Options> for the date range to be displayed. The data shown is the wide window results.

To Delete Any Background Measurement:

- 1. At the Background Data screen, highlight the date to delete and then select <Delete>.
- 2. Select <OK> to delete the entry and return to the Background Data screen.

To Change Viewing Options:

If desired, the Background list can be altered to show all background measurements, today's background measurements, background measurements prior to a specific date, or background measurements from a selected date.

- 1. At the Background Data screen, select <Options> to advance to the Background Data Options screen.
- 2. Select <Option> to toggle through the background data viewing options. To view "All" background measurements, "Today's" background measurements only, background data prior to a selected date, between selected dates, or from a selected date, toggle to the desired choice and select <Enter>. The View Background Data screen is now displayed with the appropriate background list. The total number of records selected is also displayed.
- 3. Select the appropriate <Date> field and then enter the desired date or date range using the <▲> or <▼> icons. Select <Enter> after completing each field to record the new date.
- 4. Once the date fields are completed, select <Enter> to return to the Background Data screen with background measurements for the selected date(s) now displayed.
- 5. For a more detailed view of any background measurement, highlight the desired background measurement and then select <View Data>. The Background View Details screen is displayed with the measurement specifics including Status, Background Activity, Full Spectrum and Technologist. Use the <▲> or <▼> icons immediately to the right of the Background Activity list to scroll to any additional isotopes. Select <Back> to return to the Background Data screen.
- 6. Background data can be printed in a Summary Report or Detail Report format. At the Background Data screen, select <Options>, then select <Summary Report> for a summary report of background measurements giving the results for each available isotope.
- 7. Select <Detail Report> for a detailed report of background measurements.
- 8. Select <Print> at any time to print the Background Data screen, Summary Report or Detail Report.

Background Detail Report

Biodex Model 086-331 Serial # 08070015 Detector Serial # 8070003 Printed: 01/28/2009 14:31

Date Tir	ne (secs)	Status		Cnts>800ke	ry isotope	СРМ	DPM	Technologist
1/28/09 14:18	60	Ok	495	137		495.0		AMA
					Wide Window	494.0	4,038	
					Ba-133	102.0	828	
					Co-57	41.0	47	
					Co-60	137.0	269	
					Cr-51	67.0	1,572	
					Cs-137	73.0	597	
					Ga-67	223.0	438	
					I-123	37.0	29	
					I-125	7.0	25	
					I-131	62.0	173	
					In-111	185.0	293	
					Tc-99m	25.0	32	
					TI-201	47.0	95	
1/28/09 14:11	60	Ok	562	0		562.0		AMA
					Wide Window	562.0	4,593	
					Ba-133	100.0	812	
					Co-57	57.0	65	
					Co-60	0.0	0	
					Cr-51	61.0	1,431	
					Cs-137	101.0	826	
					Ga-67	251.0	493	
					I-123	42.0	33	
					I-125	11.0	39 167	
					I-131	60.0 189.0	300	
					In-111 Tc-99m	49.0	63	
					TI-201	53.0	107	
					11-201		107	
1/20/09 14:33	60	Ok	537	169		537.0		AMA
					Wide Window	537.0	4,389	
					Ba-133	92.0	747	
					Co-57 Co-60	48.0 169.0	55 332	
					Cr-51	57.0	1,338	
					Cs-137	84.0	687	
					Ga-67	235.0	461	
					I-123	35.0	28	
					I-125	2.0	7	
					I-131	57.0	159	
					In-111	173.0	274	
					Tc-99m	30.0	39	
					TI-201	57.0	115	
	nroved Pro-					Date:		
Ар	proved By:					Date.		page 1 of 2

Figure 6.11. A printed Background Detail Report.

View Stored Wipe Data

(See Figure 6.12 - 6.14.)

Stored Wipe Data									
Wipe Counter bench									
Biodex Mod	el 086-332 Serial # 1008002p		Detector Serial # 9020011						
Date	Location	Status	Net CPM	Net Activity					
02/02/12 12:45 PM	camera rm 1	PASS	-54.0	-152 DPM					
02/02/12 12:45 PM	camera rm 1	PASS	-60.0	-169 DPM					
02/02/12 12:42 PM	camera rm 1	PASS	1,650.0	4,682 DPM					
01/10/12 2:46 PM	hot lab	FAIL	8,616.0	24,449 DPM					
01/10/12 2:44 PM	hot lab	PASS	72.0	204 DPM					
01/09/12 2:37 PM	hot lab	FAIL	6,942.0	19,699 DPM					
12/26/11 9:36 PM	Co-57 s-vial	FAIL	39,000.0	0.0498 uCi					
12/26/11 9:31 PM	camera rm 1	FAIL	7,170.0	20,346 DPM					
0		×	\Box (
Back	Options View Wipe	Delete	Earlier La	ter Print					

Figure 6.12. The Stored Wipe Data Summary screen.

The View Stored Wipe Data function allows the user to view data for any wipe test stored in the system. It displays the date, location, status, net CPM, net activity, along with the Biodex Wipe Test Counter model number, display serial number and detector serial number. Users can choose to view the entire list of wipe tests, or select specific dates to review. If desired, View Wipe Details can be displayed. Unwanted wipe tests can also be deleted.

To View All Wipe Tests:

1. At the Wipe Test Counter QA screen, select <View Stored Wipe Data>. The Stored Wipe Data screen is now displayed with a listing of all wipes performed. Use the <▲> or <▼> icons to scroll though the list if you desire to see entries from earlier or later dates that are not displayed.

To Delete Any Stored Wipe Test:

- 1. At the Wipe Test Data screen, highlight the wipe to delete and then select <Delete>.
- 2. Select <OK> to delete the entry and return to the Wipe Test Data screen.

To Views A Specific Wipe's Detail:

1. Highlight the specific wipe test and then select <View Wipe>. The wipe detail information is now displayed.

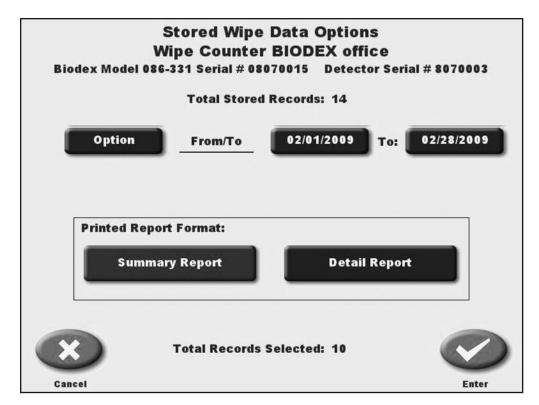


Figure 6.13. The Stored Wipe Data Options screen.

To Change Viewing Options:

If desired, the Wipe Test list can be altered to show all wipes, today's wipes, wipes prior to a specific date, wipes between selected dates, or wipes from a selected date.

- 1. At the Stored Wipe Data screen, select <Options> to advance to the Stored Wipe Data Options screen.
- 2. Select <Option> to toggle through the wipe data viewing options. To view all wipes, today's wipes, wipes prior to a specific date, wipes between selected dates, or wipes from a selected date toggle to the desired choice and select <Enter>. The Wipe Data screen is now displayed with the appropriate Wipes list.
- 3. Select the appropriate <Date> field and then enter the desired date or date range using the <♠> or <▼> icons. Select <Enter> after completing each field to record the new date.
- 4. Stored Wipe Test data can be printed in a Summary Report or Detail Report format. At the Stored Wipe Data screen, touch <Summary Report> for a summary report of the wide window wipe data, or touch <Detail Report> for a detailed report showing all wipes.
- 5. Once the option date fields and report format are completed, select <Enter> to return to the Stored Wipe Data screen with wipes for the selected date(s) now displayed.
- 6. For a more detailed view of any displayed wipe, highlight the desired wipe and then select <View Wipe>. The Wipe View Details screen is displayed with the measurement specifics including Date, Location, Status, net CPM, Net Activity and Technologist.
- 7. Select <Print> at any time to print the Stored Wipe Data screen. The Summary Report or Detail Report will print depending on the option selected in step 4.

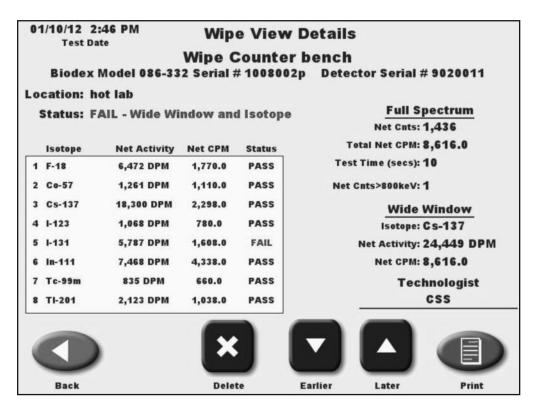


Figure 6.14. Stored wipe view details for an individual wipe test.

Chi-Square

(See Figure 6.15 and 6.16.)

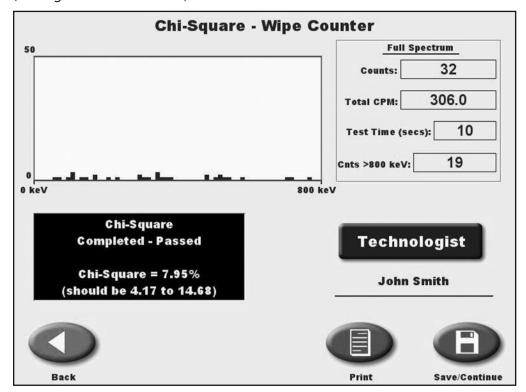


Figure 6.15. The Chi-Square screen.

As is the case with daily calibration, Chi-Square is performed using a 0.1 μ Ci Cs-137 rod source. The Chi-Square test is independent of the counting time, counting rate, and number of counts performed. For this reason, Chi-Square is a very valuable test for a detector system which is recording truly random events. For example, if systematic failure occurs at low counting rates but passes at high rates, there is an indication of a non-random event occurring which is comparable to the low counting rates. Since time is precise to within 10 microseconds with a crystal controlled clock, 10-second count times should have very little error due to the timer itself.

The number of counts performed is 10, which determines the number of degrees of freedom (9) for the analysis. The lower limit is 4.168, the upper limit is 14.68. These correspond to a 90% probability for passing the lower limit, and 10% probability for passing the upper limit, respectively. In all, one would expect a 20% failure rate frequency for the Chi-Square test. It is not reasonable to always pass or always fail Chi-Square without raising concerns that there may be a systematic problem in the detector or counter.

NOTE: The system stores the information for the Chi-Square test performed on a detector. Chi-Square can be performed as frequently as desired, but is generally performed quarterly, or after performing a high voltage test.

To Perform Chi-Square:

- 1. Ensure the area is clear of background contamination and the detector is free of radioactive sources.
- 2. At the Wipe Test Counter Quality Assurance screen, select <MDA and Chi-Square>. The Wipe Test Counter QA screen is displayed.
- 3. Select <Chi-Square> to advance to the Chi-Square screen.

NOTE: It is recommended to use 0.1 μCi Cs-137 Rod Source

4. Place the Cs-137 calibration rod source into the wipe detector and select <Start>. The system begins counting ten samples. Progress is noted in the Chi-Square In Progress window.

NOTE: Once the Chi-Square is started, care should be taken not to move the source or the detector.

- 5. When counting is completed, a Chi-Square Completed prompt will be displayed, along with the pass/fail result, Chi-Square value and acceptable range.
- 6. If you need to enter or change the technologist, touch <Technologist>. The Technologist List will be displayed.

To enter a new technologist:

- Touch <Add Technologist>.
- Use the keypad to enter the technologist name and touch <Enter>. The new technologist name will be added to the Technologist list.
- Touch to highlight the technologist name desired from the Technologist List and then touch <Enter>. The system returns to the Chi-Square screen with the new technologist selected.
- 7. Touch <Print> to print out a copy of the current Chi-Square, if desired.
- 8. Touch <Save/Continue> to record and save the Chi-Square. The display returns to the Wipe Test Counter QA screen.

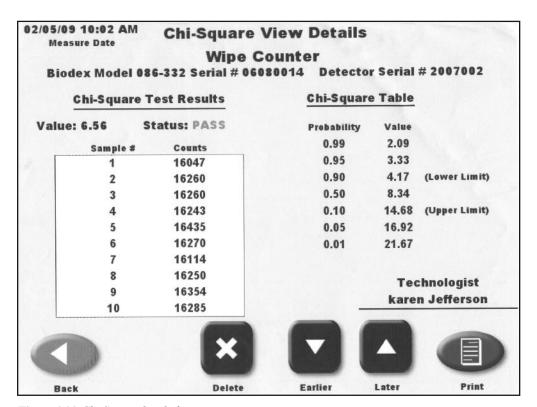


Figure 6.16. Chi-Square details from test.

View Chi-Square

(See Figure 6.17.)

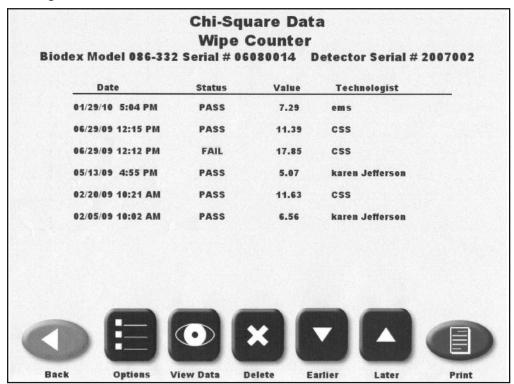


Figure 6.17. The Chi-Square data screen.

To View Chi-Square Data:

1. At the Wipe Test Counter QA screen, select <View Chi-Square Data>. The Chi-Square Data screen is now displayed with a listing of Chi-Square tests performed. Use the <▲> or <▼> icons to scroll though the list if you desire to see entries from earlier or later dates.

To Delete Any Chi-Square Test:

- 1. At the Chi-Square Data screen, highlight the Chi-Square to delete and then select <Delete>.
- 2. Select <OK> to delete the entry and return to the Chi-Square Data screen.

To Change Viewing Options:

If desired, the Chi-Square list can be altered to show all Chi-Square tests, today's tests, tests prior to a specific date, or tests from a selected date.

- 1. At the Chi-Square Data screen, select <Options> to advance to the Chi-Square Data Options screen.
- 2. Select <Option> to toggle through the Chi-Square viewing options. To view "All" Chi-Square data, or "Today's" Chi-Square only, toggle to the desired choice and select <Enter>. The Chi-Square Data screen is now displayed with the appropriate Chi-Square list.
- 3. To view Chi-Square Data prior to a selected date, between selected dates, or from a selected date, use <Option> to toggle to the desired setting.
- 4. Select the appropriate <Date> field and then enter the desired date or date range using the <▲> or <▼> icons. Select <Enter> after completing each field to record the new date.
- 5. Once the date fields are completed, select <Enter> to return to the Chi-Square Data screen with Chi-Square for the selected date(s) now displayed.
- 6. For a more detailed view of any Chi-Square, highlight the desired test and then select <View Detail>. The Chi-Square View Details screen is displayed with the measurement specifics including Date, Value, Status, Sample #, Counts, a Chi-Square Table with Probability and Value, Technologist, and Atomlab Wipe Test Counter and Detector serial numbers.
- 7. Select <Print> at any time to print the Chi-Square Data screen or Chi-Square View Details screen.

Chi-Square Formula

Mean:
$$\overline{N} = \sum_{i=1}^{n} \frac{N_i}{n}$$

Chi-Square:
$$\chi^2 = \sum_{i=1}^{n} \frac{(N_i - \overline{N})^2}{\overline{N}}$$

n = Number of Measurements

 χ^2 = Chi-Square

 N_i = Measurement

 \overline{N} = Mean

Example Chi-Square Calculation

Sample #	Ni
1	106264
2	106300
3	106358
4	106909
5	106384
6	107199
7	106794
8	106203
9	106822
10	106485
	$\overline{N} = 1065718 \div 10 = 106571.8 = \overline{N}$

$$(N_i - \overline{N})$$
 $(N_i - \overline{N})^2$

$$106264 - 106571.8 = (307.8)^2 = 94740.84$$

$$106300 - 106571.8 = (271.8)^2 = 73875.24$$

$$106358 - 106571.8 = (213.8)^2 = 45710.44$$

$$106909 - 106571.8 = (337.2)^2 = 113703.84$$

$$106384 - 106571.8 = (187.8)^2 = 35268.84$$

$$107199 - 106571.8 = (627.2)^2 = 393379.84$$

$$106794 - 106571.8 = (222.2)^2 = 49372.84$$

$$106203 - 106571.8 = (368.8)^2 = 136013.44$$

$$106822 - 106571.8 = (250.2)^2 = 62600.04$$

$$106485 - 106571.8 = (-86.8)^2 = 7534.24$$

$$\Sigma = 1012199.60$$

$$\chi^{2} = \sum_{i=1}^{n} \frac{\left(N_{i} - \overline{N}\right)^{2}}{\overline{N}}$$

$$\chi^2 = \frac{1012199.60}{106571.8} = 9.4978184 = 9.50$$

Stored Chi-Square Report Biodex Model 086-332 Serial # 06080014 Detector Serial # 2007002 02/05/2009 10:02 AM Measure Date Chi-Square Table **Chi-Square Test Results** Value: 6.56 Status: PASS Probability 0.99 Value 2.09 Sample # Counts 16047 0.95 0.90 16260 3.33 23456789 16260 4.17 (Lower Limit) 16243 0.50 8.34 0.10 0.05 14.68 16.92 16435 (Upper Limit) 16270 21.67 16114 0.01 16250 16354 16285 10 Technologist: karen Jefferson

Figure 6.18. A printed, Stored Chi-Square Report.

Approved By:

Minimum Detectable Activity (MDA)

(See Figure 6.19.)

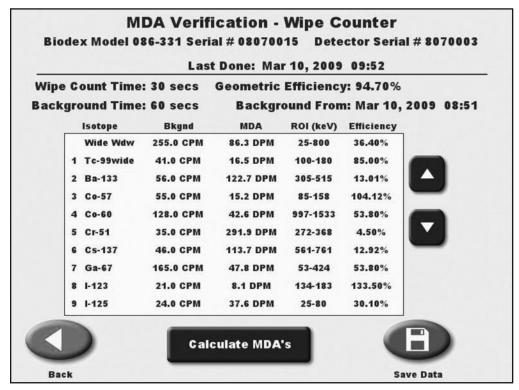


Figure 6.19. The MDA Verification screen.

To determine Minimal Detectable Activity (MDA) Verification, the system calculates, based on background, the smallest activity that can be detected for the specific nuclide or region of interest. MDA should be performed whenever the background or high voltage activity changes (i.e., the unit is moved to a new location, or a new source of radiation is located nearby.)

To Perform MDA Verification:

- 1. Ensure the area is clear of background contamination and the detector is free of radioactive sources.
- 2. At the Wipe Test Counter QA screen, select <MDA and Chi-Square>. The Wipe Test Counter QA screen is displayed.
- 3. Select <MDA Verification> to advance to the MDA Verification screen.
- 4. Select <Calculate MDA's>. The system automatically calculates the MDA value, based on background, for each isotope listed with an efficiency. The system will display the isotope, Background, MDA, ROI (keV) and Efficiency, along with the wipe and background times. The Background From date is also displayed.
- 5. If desired, use the $\langle \blacktriangle \rangle$ or $\langle \blacktriangledown \rangle$ icons scroll up or down the MDA list to show additional isotopes.
- 6. To save the newly calculated MDA's, select <Save Data>. The results are saved and the system returns to the MDA Verification screen.
- 7. If desired, select <Print> to print the MDA Verification screen.

NOTE: The system only stores the current calculation of MDA information. Previous MDA calculations are not saved. Be sure to print the current MDA calculations for your records.

MDA is calculated using the following equation:

NOTE: The system assumes a 100 cm² wipe.

Determining MDA for Radiation Measurements

U.S. Government formula for MDA (Minimum Detectable Activity)

MDA =
$$\frac{(2.71 / T_s) + 3.29 \sqrt{(R_b/T_b + R_b/T_s)}}{E \cdot (A / 100 cm^2)}$$

MDA =
$$\frac{(2.71 / T_s) + 3.29 \sqrt{(R_b/T_b + R_b/T_s)}}{\text{Det efficiency x Geometric efficiency x area/100 cm}^2)}$$

NOTE: The system assumes a 100 cm² wipe.

 R_B = count rate of the natural background

 T_{B} = time of the background count

 T_s = time of the sample count

E = detection efficiency of the counter

A = area monitored or wiped

NOTE: E = Detector efficiency x Geometric efficiency

NOTE: Wipe area program assumes $100 \text{ cm}^2 / 100 \text{ cm}^2 = 1$

MDA Examples

Geometric eff 96.82% Wipe Count 10 sec = T_s = .166667 minutes Bkgnd Count 30 sec = T_b = .5 minutes

MDA =
$$\frac{(2.71/T_s) + 3.29\sqrt{(R_b/T_b + R_b/T_s)}}{\text{Det eff x Geo eff x (A/100 cm}^2)}$$

Example a) Co-57

MDA =
$$\frac{(2.71/.166667) + 3.29\sqrt{(70/.5 + 70/.166667)}}{.909 \times .9682 \times 1}$$
MDA =
$$\frac{16.26 + 3.29\sqrt{(140 + 420)}}{.8800938}$$
MDA =
$$\frac{16.26 + 77.85561}{.8800938} = 106.93 \text{dpm}$$
.8800938
System 106.9dpm

Example b) TI-201

MDA =
$$\frac{(2.71/.166667) + 3.29\sqrt{(46/.5 + 46/.166667)}}{.505 \times .9682 \times 1}$$
MDA =
$$\frac{16.26 + 3.29\sqrt{(92 + 276)}}{.488941}$$
MDA =
$$\frac{16.26 + 63.113}{.488941} = 162.33685 dpm$$
System 162.3dpm

7. System Configuration

System Configuration

(See Figure 7.1.)

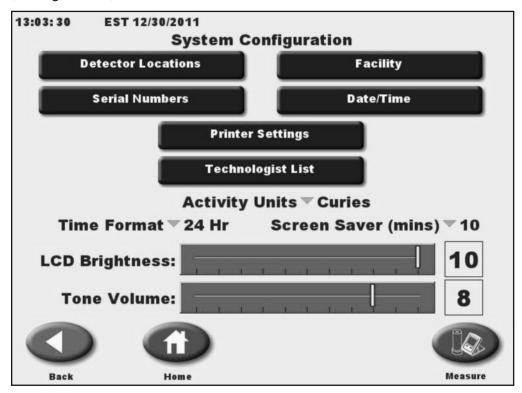


Figure 7.1. The System Configuration Menu.

The System Configuration options allow the user to enter or customize various system-wide parameters. Any changes made to the configuration settings are permanently saved when exiting the Configuration screen.

Touch <System Configuration> on the Utilities Menu to access the System Configuration screen.

Detector Locations

(See Figure 7.2.)

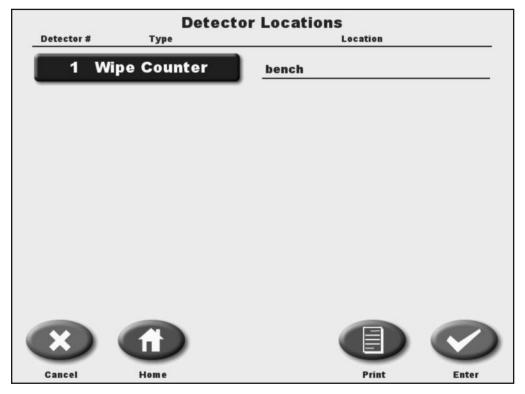


Figure 7.2. The Detector Locations screen.

The Atomlab Wipe Test Counter display automatically senses every detector connected and can tell what type it is. Detectors are listed numerically with detector # 1 being the lowest ID number. < Detector Locations > allows the user to specifically label the location of any connected detector.

To Label A Detector:

- 1. Touch <Detector Locations> on the System Configuration screen. The Enter Password screen is now displayed.
- 2. Enter your password and touch <Enter>. The Detector Locations List is displayed.
- 3. Touch the detector to label. The Enter Location screen is displayed.
- 4. Key in the detector location and touch <Enter> to return to the Detector Locations screen. If desired, repeat the process for any other detector. Touching <More Detectors> will advance you to the next page of listed detectors if there are more detectors connected than listed on the screen. The <More Detectors> prompt will not show unless enough detectors are connected.

NOTE: Each detector connected to a display must have a different ID number. ID number can be changed, see "Detector Management".

- · Touch <Print> to generate a printout of the detector location.
- · Touch <Enter> to record the detector location and return to the System Configuration screen.
- Touch <Cancel> to return to the System Configuration screen without recording a new detector location.

Serial Numbers

(See Figure 7.3.)

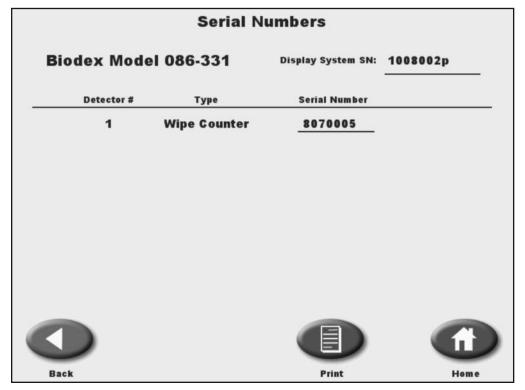


Figure 7.3. The Serial Numbers screen.

This option displays a list of all entered serial numbers for the display and detectors. The detector serial numbers are recorded in the detector and automatically communicated to the display.

To View Serial Numbers:

- 1. Touch <Serial Numbers >. The Enter password screen is displayed.
- 2. Enter your password and touch <Enter>. The Serial Numbers screen is displayed with a listing of all serial numbers recorded for the system.
- 3. Touch < > to return to the system configuration screen.

NOTE: Serial numbers can only be viewed on this screen. You cannot change the serial number.

Facility

(See Figure 7.4.)

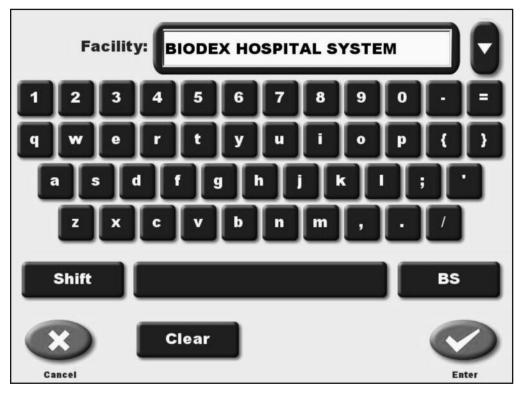


Figure 7.4. The Enter Facility screen.

This option allows the user to enter or change the facility name and address. You can enter up to four lines of text for this parameter. The facility name and address entered will appear on some printed reports.

To Enter or Change the Facility Name:

- 1. Touch <Facility>. The Enter password screen is displayed.
- 2. Enter your password and touch <Enter>. The Enter Facility screen is displayed.
- 3. Key in the new facility name and address, then touch <Enter> to return to System Configuration screen with the new name selected, or <Cancel> to exit without updating the facility name.
- 4. Use the <▼> at the top right of the screen to move to each line of the address. You can add the phone number if desired as part of the address.

NOTE: There are a maximum of 4 lines to the address. You can put your phone number as part of the address.

Set Date/Time

(See Figure 7.5)

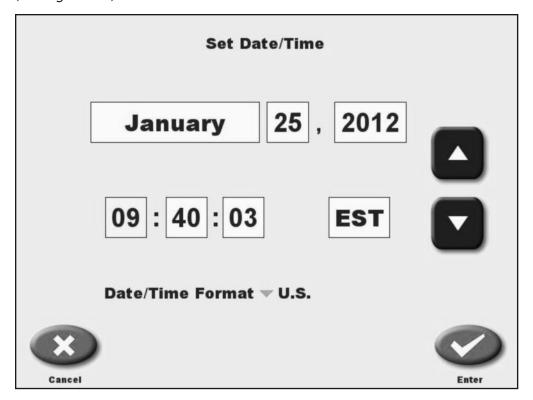


Figure 7.5. The Set Date/Time screen.

This option allows the user to enter or change the system clock and calendar, select the desired time format and, if in the USA region, select standard or daylight savings time.

To Set Date/Time:

- 1. Touch <Date/Time>. The Enter password screen is displayed.
- 2. Enter your password and touch <Enter>. The Set Date/Time screen is displayed.
- 3. Touch to highlight the time or date component to change and then use the <▲> or <▼> keys to scroll to the desired setting. For Time Zone, choose from EST, EDT, CST, CDT, MST, MDT, PST, PDT or blank.
- 4. If you need to change the date/time format, touch the current country to access the country list. Touch the desired country to select. Not all countries are listed. Select a country with the same time format you require.
- 5. Touch <Enter> to return to System Configuration screen with the new time/date, or <Cancel> to exit without updating the date/time entry.

Activity Units

Accessed from the Dose Calibrator Configuration screen, this option is used to change from the default Activity Units (Curies). To change to Becquerels, touch the Activity Units value current setting and then touch your selection from the pop-up list. Touch any part of the screen while the pop-up list is displayed to cancel without making any changes.

Time Format

The Time Format option allows the user to select from a 24-hour clock or a.m./p.m. clock format. Simply touch the <Time Format> value to make the change. Touch <Back> to return to the Utilities menu.

Printer Settings

(See Figure 7.6)

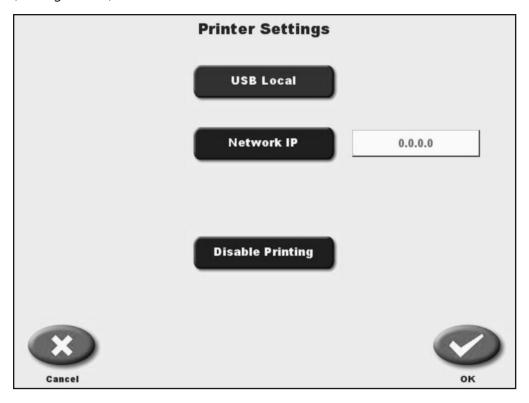


Figure 7.6. The Printer Settings screen.

Printer settings can be set to allow for a USB local printer, Network IP address, or to disable printing.

To Select USB Local printing:

- 1. From the <Home> screen, touch <Utilities>. The Utilities screen is now displayed.
- 2. Touch <System Configuration>. The System Configuration screen is now displayed.
- 3. Touch <Printer Settings>. The Printer Settings screen is now displayed.
- 4. Touch to highlight <USB Local>.
- 5. Touch <OK> to select USB Local printing and return to the System Configuration screen, or <Cancel> to return to the System Configuration screen without changing the current printer setting.

To Select Network IP printing:

- 1. From the <Home> screen, touch <Utilities>. The Utilities screen is now displayed.
- 2. Touch <System Configuration>. The System Configuration screen is now displayed.
- 3. Touch <Printer Settings>. The Printer Settings screen is now displayed.
- 4. Touch to highlight <Network IP>.
- 5. Enter the IP address and touch <Done>. The IP address entered should now be displayed next to the Network IP button.
- 6. Touch <OK> to select the displayed IP address and return to the System Configuration screen, or touch <Cancel> to return to the System Configuration screen without changing the current printer setting.

To Disable Printing:

- 1. From the <Home> screen, touch <Utilities>. The Utilities screen is now displayed.
- 2. Touch <System Configuration>. The System Configuration screen is now displayed.
- 3. Touch <Printer Settings>. The Printer Settings screen is now displayed.
- 4. Touch to highlight <Disable Printing>.
- 5. Touch <OK> to select Disable Printing and return to the System Configuration screen, or touch <Cancel> to return to the System Configuration screen without changing the current printer setting.

Technologist List

(See Figure 7.7.)

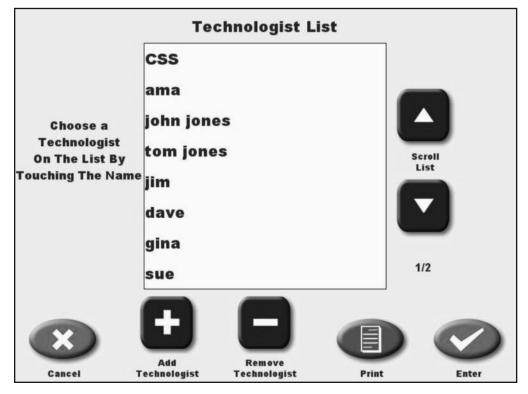


Figure 7.7. The Technologist List screen.

The Technologist List allows a specific technologist to be associated with any Atomlab 500 QA test. Technologists are listed in the order entered. New technologists may be added to the list and technologists may also be removed. Technologists can also be added to the Technologist List as part of the save procedure after performing any QA Test.

To Access The Technologist List:

- 1. From the <Home> screen, touch <Utilities>. The Utilities screen is now displayed.
- 2. Touch <System Configuration>. The System Configuration screen is now displayed.
- 3. Touch <Technologist List >. The Technologist List is now displayed.

To Select A Technologist From The Technologist List:

- 1. Touch to highlight the desired technologist on the Technologist List. If necessary, use the <▲> and <▼> arrows to scroll up and down the Technologist List until the desired technologist is displayed.
- 2. Touch <Enter> to record your selection and return to the System Configuration screen, or <Cancel> to return to the System Configuration screen without changing the selected technologist.

To Add A Technologist To The Technologist List:

- 1. Touch <Add Technologist> and then enter the technologist name in the Technologist field. The Technologist name entered now appears at the bottom of the Technologist List.
- 2. Touch <Enter> to record your selection and return to the System Configuration screen, or <Cancel> to return to the System Configuration screen without adding a new name to the Technologist List.

To Remove A Technologist From The Technologist List:

- 1. Touch to highlight the technologist to remove from the Technologist List. If necessary, use the <▲> and <▼> arrows to scroll up and down the Technologist List until the desired technologist is displayed.
- 2. Touch <Remove Technologist>. The highlighted technologist name is removed from the Technologist List.
- 3. Touch <Enter> to record your selection and return to the System Configuration screen, or <Cancel> to return to the System Configuration screen without deleting the highlighted technologist name.

To Print The Technologist List:

1. At the Technologist List, touch <Print>. The Technologist List will print to the currently selected printer.

Screen Saver (mins)

The display screen can be set to stay on continuously, or to turn OFF after 5, 10, 20 or 30-minute intervals. Allowing the screen to turn off does not turn the system OFF – it turns OFF only the display screen.

To Change Screen Saver Time:

- 1. Touch the <Screen Saver> value to view a listing of settings.
- 2. Touch the desired setting to select. The system returns to the System Configuration screen with new selected setting.

NOTE: If the screen turns OFF at any time, touch the screen to reactivate the display.

LCD Brightness

The display's LCD brightness can be set from 1 (least bright) to 10 (brightest.) Touch the desired value on the LCD brightness scale to set.

Tone Volume

The system volume can be set from 1 (lowest) to 10 (loudest). Touch the desired value on the Tone Scale to set.

- · Touch <Home> to return to the Home screen.
- · Touch <Back> to return to the Utilities screen.
- · Touch <Measure> to return to the Count screen.

8. System Maintenance

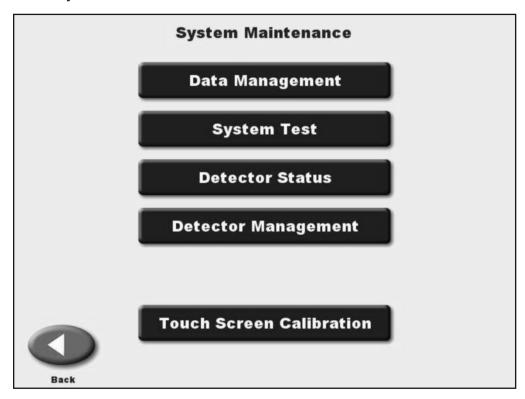


Figure 8.1. The System Maintenance screen.

The System Maintenance option is used to address various system maintenance functions including:

- · Data Management
- · System Test
- · Detector Status
- · Detector Management
- · QA Data Management
- · Touch Screen Calibration

To access the System Maintenance options, at the Home screen select <Utilities>. From the Utilities screen, select <System Maintenance> to arrive at the System Maintenance screen.

Data Management (See Figures 8.2. and 8.3.)

	Summai	-	of Store ambers	d QA Data	
L)	Biodex Mo	del 086-33	2 Serial # 1	1008002р —	
	Oldest	Newest	Count	Total Capacit	у
Constancy	11/14/2011	02/15/2012	33	12000	
Geometry	11/17/2011	02/12/2012	11	2000	
Accuracy	11/17/2011	02/12/2012	16	2000	
Decay	11/14/2011	02/12/2012	35	2000	
Lineator	11/18/2011	12/26/2011	5	2000	
Calicheck	12/14/2011	12/14/2011	1	2000	
HV Adjustment	10/27/2011	02/05/2012	7	2000	
Calibration	10/24/2011	12/02/2011	2	4000	
Background	10/24/2011	02/14/2012	25	8000	
Wipe Data	12/01/2011	02/05/2012	30	24000	
Chi-Square Data	12/01/2011	02/05/2012	6	2000	
Wipe Constancy	11/02/2011	02/14/2012	26	4000	
Total:	10/24/2011	02/15/2012	197	66000	
0			0		
Back	Select Dete	ctor Exp	ort	Import	Delete

Figure 8.2. The summary View of All Stored QA Data.

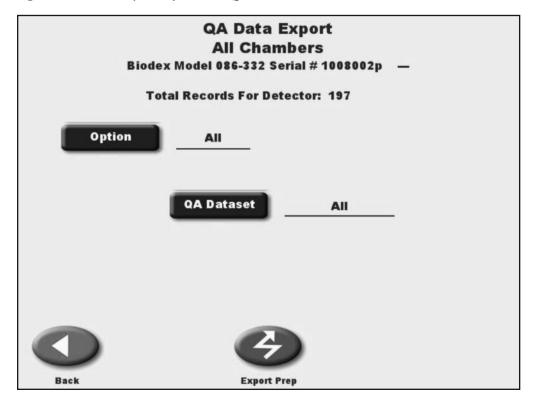


Figure 8.3. The QA Data Export screen.

QA Data Management allows the user to view, delete, export and import the results of QA tests to a thumb drive for a selected detector or all detectors. The user can select from all tests, tests prior to or after a specified date, or within a specific date range. To choose data for a specific detector, toggle the <Select Detector> button at the bottom of the screen until the desired information is displayed.

NOTE: Be sure to install the thumb drive in one of the USB ports, located on the back of the display panel, before attempting to export, import or back up QA and system data.

To Export QA Data Management:

- 1 On the System Maintenance screen, touch <Data Management>.
- 2. Enter your password and touch <Enter>.
- 3. Select <QA Data Managment>. The Summary View of Stored QA Data screen is displayed with results for all tests on all detectors listed (or results for a specific detector, if selected.)
- 4. Touch <Export>. The QA Data Export screen is displayed.
- 5. Touch <Option> to select the date range for the data to export. Choose from All, Prior To, From/To, From or Only New by continuing to touch <Option> to advance through the choices.
- 6. For all choices other than All and Only New, touch the date to change it.
- 7. Touch the date segment to change and use <**\triangle**> or <**\nabla**> to scroll to the date desired.
- 8. Touch <Enter> to confirm the new date and return to the QA Data Export screen.
- 9. Touch <QA Dataset> to view the dataset options. Choose from "All" datasets, or continue touching <QA Dataset> to scroll through the list of individual datasets: Daily Constancy, Expanded Constancy, Geometry, Accuracy, Decay, Lineator and Calicheck.
- 10. Touch <Export Prep> to export the selected dataset and return to the Summary View of Stored QA Data screen, or <Back> to return to the Summary View of Stored QA Data screen without exporting data.
- 11. Select <Export USB> or <Export Serial>. The system exports the data, notes that the export has been completed, and returns to the QA Data Export Prep screen.

To Import QA Data:

- 1. On the System Maintenance screen, touch <Data Management> and enter your password. The Data Management screen should now be displayed.
- 2. Touch <QA Data Management>. The Summary View of Stored QA Data screen is now displayed with results for all tests on all detectors listed (or results for a specific detector, if selected.)
- 3. Make sure a thumb drive containing data is plugged into one of the USB ports on the back of the display.
- 4. Touch <Import>. The QA Data Import screen is now displayed with the drive from which to import data noted at the top of the screen.
- 5. Use the up and down arrows to scroll to the data you wish to import. Touch the data name to highlight and advance to the Okay to Proceed screen.
- 6. Touch <Yes> to import the data selected. The system shows an export screen while the data is transferred. Once the data transfer is complete, the Import Completed Successfully screen is displayed. Touch <No> to return to the QA Data Management screen without importing data.
- 7. At the Import Successfully Completed screen, touch <OK> to return to the Summary View of Stored QA Data screen.

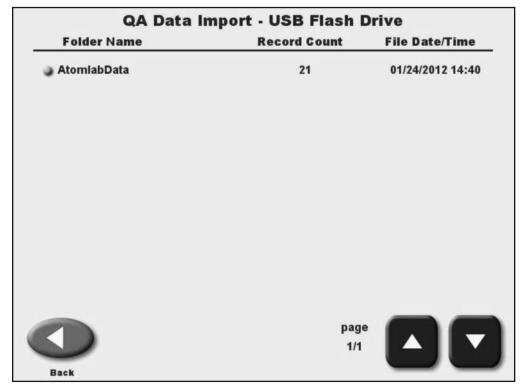


Figure 8.4. The QA Data Import screen.

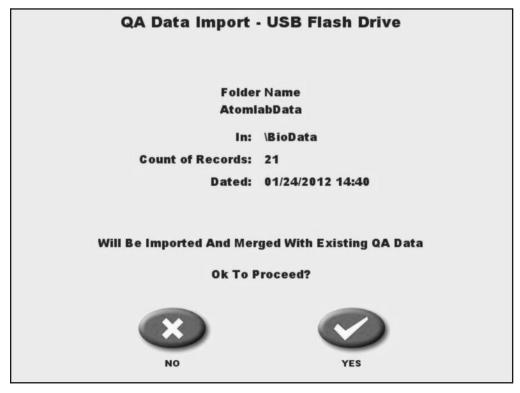


Figure 8.5. The QA Data Import Okay to Proceed screen.

To Delete QA Data:

- 1. On the System Maintenance screen, touch <Data Management> and enter your password. The Data Management screen should now be displayed.
- 2. Touch <QA Data Management>. The Summary View of Stored QA Data screen is now displayed with results for all tests on all detectors listed (or results for a specific detector, if selected.)
- 3. Touch <Delete>. The QA Data Delete screen is displayed.
- 4. Touch <Option> to select the date range for the data to export. Choose from All, Prior To or From/To by touching <Options> to advance through the choices.
- 5. For all choices other than All and Only New, touch the date to change. The QA Data Delete screen is displayed.
- 6. Touch the date segment to change and use <▲> or <▼> to scroll to the date desired.
- 7. Touch <Enter> to confirm the new date and return to the QA Data Delete screen.
- 8. Touch <QA Dataset> to view the dataset options. Choose from "All" datasets, or continue touching <QA Dataset> to scroll through the list of individual datasets.
- 9. Touch <Delete Now> to delete the selected dataset and return to the Summary View of Stored QA Data screen.

System Test

(See Figure 8.6.)

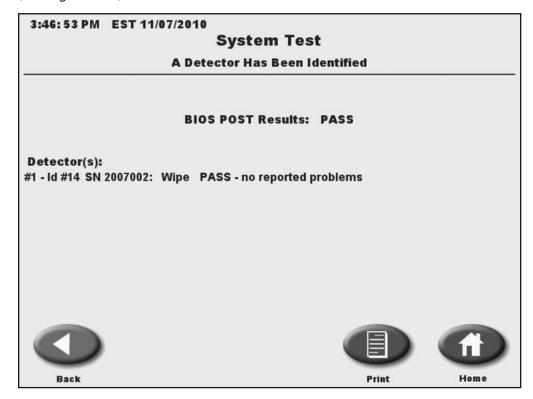


Figure 8.6. The System Test screen.

<u>Touch <System Test> to display a system-wide diagnostics test, performed at power-up,</u> which covers the following:

- · BIOS Post Results
- Detector(s): (Detector status information is continually monitored.)

During the Power ON test, the display will show a "Detector Identification In Progress," message. If all tests are completed without errors, the system will note that there are no reported problems. If a problem is discovered, the system will note the failure with an error message and, depending on the problem, possible solutions.

- If a printed System Test report is required, touch <Print> to print the System Test screen following the test.
- · Touch <Home> to return to the system Home Page.
- · Touch <Back> to return to the System Maintenance screen.

Detector Status

(See Figure 8.7.)

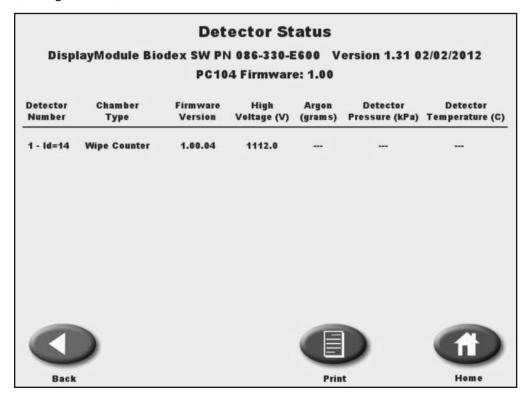


Figure 8.7. The Detector Status screen.

The Detector Status screen lists all the detectors present by number and ID, type, firmware versions on the detector PC board, the high voltage reading (V) and on dose calibrator chambers: Argon (grams), detector pressure (kPa,) and detector temperature (C-degrees) are also noted.

To view the Detector Status screen, from the System Maintenance screen touch <Detector Status>.

If a printed Detector Status report is required, touch <Print> to print the Detector Status screen. Touch <Home> to return to the system Home Page, or <Back> to return to the System Maintenance screen.

NOTE: Wipe Counter will list only firmware version and high voltage information.

Detector Management

(See Figure 8.8.)

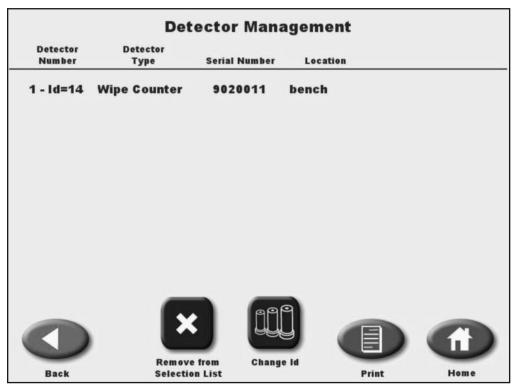


Figure 8.8. The Detector Management screen.

Detector Management allows the user to remove detectors from the Selections List and change detector ID numbers.

To Access The Detector Management Screen:

- 1. On the System Maintenance screen, touch <Detector Management>.
- 2. Enter your password and touch <Enter>. The Detector Management screen is displayed with detector I.D. numbers, detector types, serial numbers and detector locations. The <Remove From Selection List> button toggles with an <Add to Selections List> button on the Detector Management screen.

To Remove a Detector:

- 1. Touch to highlight the detector to remove.
- 2. Touch <Remove From Selection List>. A red "X" appears next to the detector to remove.

To Add a Detector:

- 1. Touch to highlight the detector to add.
- 2. Touch <Add To Selection List>. The red "X" disappears from next to the detector to remove.

To change I.D.:

- 1. Touch to highlight the detector for which to change I.D.
- 2. Touch <Change I.D.>.
- 3. The current Detector ID is listed as "From". Use <▲> or <▲> to scroll to the appropriate new ID besides the "To" prompt.
- 4. Touch <Enter>. The system will prompt "Are You Sure?" Touch <Yes> to confirm or <No> to return to the Change Hardware Detector ID screen without making changes.
- 5. If you have elected to change the Detector ID, the system will automatically reset at this point and run a new Power ON self-test. Touch <Home> to return to the system Home Page.

NOTE: Each chamber connected must have a different ID number. You cannot have two chambers with the same ID. ID numbers available are 2, 4, 6, 8, 10, 12 and 14. The Wipe Counter is preset to ID 14.

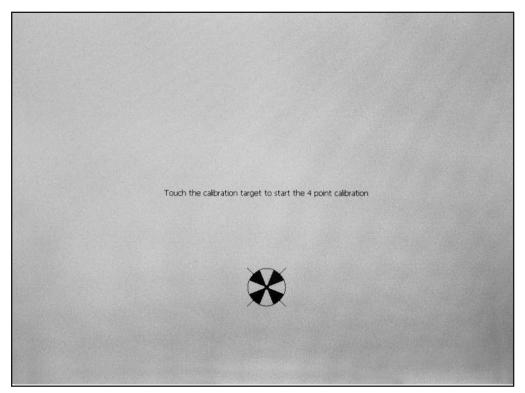


Figure 8.9. Touch screen calibration.

Appendix A: Isotope Efficiency Calculation

The total efficiency of a counting system for a specific isotope is a combination of the geometry at which the source is counted times the detector's efficiency for a specific isotope. Traditionally, the user would create a sample of a known activity, place the sample in the well counter, and then count it. The activity is converted to DPM and you have the number of counts obtained. Divide CPM by the DPM to get the efficiency.

If you changed the location of the wipe, you had to create a new standard and recalculate the efficiency.

The Biodex Wipe Test Counter separates the two components of efficiency – geometry and detector – and uses them as separate parts of the equation. This allows you to adjust the geometry and change the geometric efficiency portion of the formula without requiring a new standard and counting again to determine the new total efficiency. If you change the location (depth) in the well of the wipe, you need to adjust the geometry formula.

If the wipe or calibration source is placed one inch deep in the well, the GE = 96.82

NOTE: The Atomlab Wipe Test Counter is shipped with the Isotope Efficiency screen set to centimeters. The system is set to centimeters, as a unit of measure, as long as it is consistent for the diameter and distance. Please verify that the setup in the geometric efficiency is set to match the diameter = 1.905 cm tube supplied with this unit.

NOTE: 2" diameter = 5.08 centimeters 1.75" diameter = 4.445 centimeters

A. Geometric Efficiency (G.E.)

The value for Geometric Efficiency (G.E.) is calculated from the following equations for a well:

WELL:

G.E. _{WELL} =
$$\frac{1}{2} \left(1 + \frac{1}{\sqrt{1 + \left(\frac{|D|}{2X} \right)^2}} \right) * 100\%$$

I.D. = Inner diameter of the well opening X = Depth into the well, measured from the top surface

Example: The Biodex Nal well dimensions have an I.D. = 0.75 inches and a well depth of 1.432 inches. When the wipe (or calibration source) is placed in the well, the isotope emitting radiation will not be at the very bottom. If we take the isotope position to be 1 inch from the top, then G.E. = 96.82%.

(For X = 1.25 inches deep, G.E. = 97.89%

For X = 0.75 inches deep, G.E. = 94.72%, which are +1.07% and -2.1% respectively, from 1 inch.)

B. Detector Efficiency (D.E.)

D.E. can be calculated theoretically from system parameters or can be empirically determined by measuring the count rate from a known activity of each isotope. The empirical method results in a composite value (G.E. * D.E.) which can be reduced to D.E. by dividing by the calculated value for G.E. Only the empirical method will be discussed below. The theoretical (analytic) method is discussed (Item E) following an example calculation.

C. Efficiency Values for Wipe Testing

All isotopes for which wipes are to be counted shall either be prepared from a known liquid concentration or if possible, a standard source can be purchased in a wand form from various manufacturers. Generally, the isotopes Cs-137, Co-57, Co-60, Ba-133, and Am-241 are available in wand form with a stated activity and uncertainty. The activity should be kept in the range of 0.01 to 0.1 μ Ci, and should not exceed 0.2 μ Ci. This will generally keep the overall counting rate below 10,000 cps and will eliminate any spectrum distortion or non-linearity from playing a role in the efficiency calculation.

A suggested procedure for source preparation is outlined on the next page. The liquid source will be deposited on an absorbent material in the bottom of a plastic vial which fits inside the well. It is recommended that no more than 10 ul of liquid be dispensed in order to reduce spilling radioactive material.

Source Preparation:

- 1. Prepare an activity of 0.01 to 0.1 mCi of the isotope in 10.0 ml of saline. This will result in a concentration of approximately 0.001 to 0.01 mCi/ml. The volume should be either controlled as close as possible to 10.0 ml or precisely measured.
- 2. Assay the activity in the vial in a dose calibrator which has a resolution of 0.01 μ Ci. Compensate for background before making the measurement. Record the time of measurement.
- 3. Calculate concentration by dividing the measured activity by the source volume and record with the time of measurement.
- 4. Prepare the vial with absorbent material (such as a portion of a wipe pad or the end of a Q-tip) at the bottom of the vial.
- 5. Draw off 10 ul of source material and carefully place the end of the syringe tip at the bottom of the vial. Deposit all of the source material onto the absorbent material.
- 6. Withdraw the syringe and immediately rinse it in saline at least ten times. This will reduce the chance of contamination of the next source which will be a different isotope.
- 7. Record the activity in the test vial as A_{Xx-123} at the time T is recorded in step 2. (The Xx-123 subscript is meant to designate the isotope symbol which should be recorded, i.e., Am-241.)

NOTE: A tuberculin syringe is not suitable in this procedure. Hamilton microliter syringe, model 701-N, has a capacity of 10 ul with 0.2 ul resolution and will provide the necessary precision. Hamilton Co., P.O. Box 10030, Reno, Nevada, 89520. Phone: 800-648-5950.

Enter the source in the wipe counter efficiency mode Isotope List portion of the Atomlab Wipe Test Counter.

D. Efficiency Measurement

- 1. Make sure the Atomlab Wipe Test Counter has a current Cs-137 calibration.
- 2. Then go to the "Isotope Settings" page. Use the arrow keys <▲> or <▼> to display the isotope you wish to set the efficiency for. Select the isotope to highlight and then select <Enter>.
- 3. Select < Detector Efficiency>
- 4. Set the Geometric Efficiency using <Geometric Efficiency> near the lower right of the display. Once set, select <Enter>.
- 5. Select <Isotope Activity>. Enter the source calibration time and activity. If you press <Enter> button, the unit displays the calculated decayed activity of the standard you created.
- 6. Near the bottom of the display screen, select <Measure Efficiency>.
- 7. The display will direct you to place the efficiency source into the well and select <Start>. The system will perform an automatic 30-second minimum count on your prepared standard. The count time is based on the setting for wipe counting time. The system displays the spectrum as it counts.

NOTE: The Atomlab Wipe Test Counter will automatically record and calculate for you. We recommend at least a 60-second count time

- 8. The new calculated efficiency is shown in the Set/Edit Efficiency window.
- 9. You can print the detector efficiency for your records, if desired.

NOTE: Total efficiency is a combination of the geometric and detector efficiencies.

10. Select <Back> to return to the Isotope Settings screen.

D.E. * G.E. =
$$\frac{\frac{\text{(S - B) counts}}{100 \text{ sec}}}{\text{A}_{\mu\text{Ci}} * 37000_{\text{dps/}\mu\text{Ci}} * 2} * 100\%$$

$$OR$$

$$\frac{\text{(S - B) counts}}{100 \text{ sec}} * 100\%$$
D.E. * G.E. =
$$\frac{100 \text{ sec}}{\text{current activity displayed}} * 100\%$$

S is standard ROI counts.

B is Background ROI counts.

A is the activity determined in step 7 under Source Preparation for isotope Xx-123 with units of microcuries.

Exponent of "2":

This is a decay correction. For short lived isotopes such as Tc-99m, it is important. For long lived isotopes such as I-125, it may not be important unless the source is saved for future efficiency checks.

 $T_{1/2}$ is the half life of isotope Xx-123, in units of H, days, etc.

T and t are respectively the time of source measurement in the dose calibrator and the same of counting the source in the well detector. Both should have the same units as $T_{1/2}$.

For example:

If T = 08:31 h and t = 15:49 h, then T - t = -7.300 h.

If $T_{1/2} = 3.261$ days for Ga-67, then T - t should be converted to days = -0.3041 days. In this case, the decay result would be 0.937.

11. Calculate D.E. from the composite (D.E. * G.E.) found in step 10 above and from the calculated value of G.E. found earlier in the discussion on GEOMETRIC EFFICIENCY. The following equation defines the calculation.

D.E. =
$$\frac{(G.E. * D.E.)}{G.E.} * 100\%$$

NOTE: The two terms, D.E. * G.E. and G.E. are both calculated as percents in the earlier expressions and the above result preserves D.E. as a percentage.

Example Calculation:

Determine the detector efficiency of Am-241 in a well detector with an opening of 0.625 inches and the source located in the well at 1 inch below the surface.

Geometric Efficiency for a Well: I.D. = 0.625 inches X - 1.00 inch

G.E. = 97.7% (see earlier example)

Detector Efficiency for Am-241: A = 0.095 μ Ci @ T = 8/15/84 $T_{1/2}=432.2$ t = 5/1/93 (date counted in well)

Am-241 was programmed for gain of 12 and an ROI of 50 to 69 keV. 100 second counts resulted in the following:

$$S = 99,403$$

 $B = 83$

Now calculate the individual parts of the equation for (D.E. * G.E.)

Count rate = (S-B)/100 s = 993 cps

Disintegration rate = A μ Ci * 37000 dps/ μ Ci = 3515 dpm

Decay Correction = $2 (T-t)T_{1/2} = 2 (84.71 \text{ y} - 93.42 \text{ y})/432.2 \text{ y} = 0.986$

D.E. * G.E. = 0.286 * 100% = 28.6%

D.E. = $\{(D.E. * G.E.)/G.E.\} * 100\% = (28.6/97.7) * 100 = 29.3\%$

We should now check our result for common sense. The photon emission from Am-241 are 59.5 keV at 35.9% intensity and 26.3 keV at 2.4% intensity. The interaction probability for a 60 keV photon is very high in the Nal well detector (Nal thickness on sides and bottom is about 0.625 inches), the bulk of this interaction will be photoelectric which puts most of the counts recorded in the photopeak. The ROI is set to integrate the photo peak of 59.5 keV. Therefore, we would expect a detector efficiency to be a little less than photon intensity at 59.5 keV which it is.

Example of a Well Compared to a Probe for Counting Efficiency

If we assume the following parameters:

Isotope: Cs-137

D.E. Probe: 9.86% D.E. Well: 13.47%

G.E. Well: 96.816% for a source placed 2.54 cm deep in the well G.E. Probe: 0.278% for a source placed 21 cm in front of the probe

Probe: D.E. * G.E. = 9.86% * 0.278% = .02741%

Well: D.E. * G.E. = 13.47% * 96.816% = 13.04%

A.) If the detector counts 54 cpm that is equivalent to the following dpm for the parameters listed above.

Probe: 54 cpm/.02741% = 197,008 dpm

Well: 54 cpm/13.04% = 414 dpm

E. Analytically Determined (Theoretical) Detector Efficiencies

The following table of 25 isotopes contains analytically determined efficiency values, or efficiencies created from know activity standards, for use with this instrument. Stated with the efficiency value is lower and upper region of interest for which the efficiency is valid. In the wipe test program, these ROI's are fixed and cannot be adjusted. Therefore, these efficiency values may be used in the wipe test program of this instrument instead of empirically determining the efficiency for each isotope.

NOTE: It is recommended that you empirically determine the detector efficiency of your system, the analytically determined values are approximations.

The detector efficiency "D.E." is a composite number which allows conversion from detector counts to disintegrations for a given isotope.

Three factors affect it:

- 1. The photon intensity in the isotope decay scheme defines the number of photons which are emitted per 100 disintegrations of the isotope. This number can be less than or greater than 100% as exhibited by Cr-51 (~10%) and Co-60 (~200%). The photon energy and percent abundance in the decay scheme can be found in "Table of Radioactive Isotopes" by Edgardo Browne and Richard B. Firestone, pub John Wiley & Sons, 1986, ISBN 0-471-84909-X.
- 2. The photon interaction in the detector will produce counts which integrate to a fraction of the total number of photons passing through the detector. This will always be less than 100% and will depend upon the window thickness which the photon detector must pass through, detector crystal geometry and the photon energy. This photon interaction has been calculated using "Nal (Tl) SCINTILLATION DETECTORS", published by Bicron, manufacturer of the probe and well detectors. This publication contains two sets of curves which were used in the calculation of detector efficiency: Figure 14 "Absorption Efficiency of Nal (Tl)" for various thicknesses of Nal, and Figure 17 "X-Ray and Gamma Transmission Through Bicron Detector Windows" for various window thicknesses.
- 3. The ROI setting in the MCA determines the fraction of the MCA counts which are accumulated. Normally the ROI is adjusted around the photopeak, however, there can be several photon energies which are not included in this ROI because they may have a low emission intensity or their energies may cover a range too broad to be practical for background subtraction. The photopeak contribution to the photon calculation in the NaI crystal was calculated using "GAMMA-RAY ABSORPTION COEFFICIENTS FOR ELEMENTS 1 THROUGH 100 DERIVED FROM THE THEORETICAL VALUES OF THE NATIONAL BUREAU OF STANDARDS", published by Los Alamos Scientific Laboratory of the University of California, Los Alamos, New Mexico, Pub # LA-2237.

The Detector Efficiency (D.E.) has been calculated for the well detector. There are some isotopes that the well efficiency has not been analytically determined due to gamma ray summing in the well. You must use the empirical method for these isotopes. You may have to create a custom version of the isotope with a different ROI to properly count the isotope in the well.

Analytically Determined Detector Efficiencies

Please refer to this table below for Analytically Determined Detector Efficiency (%) settings settings on the Atomlab Wipe Test Counter. Well efficiency settings that have an * are empirically measured.

			Well	Wide Window (25-800 keV)
<u>Isotope</u>	<u>Left-ROI</u>	Right-ROI	Efficiency %	Efficiency %
Am-241	50	69	35.7	
Au-198	349	474	28.0	
Ba-133	305	515	*36.8	*83.93
Co-57	85	158	* 90.9	* 90.9
Co-58	434	933		
Co-60	997	1533	* 23.03	* 26.03
Cr-51	272	368	4.5	
Cs-137	561	761	*12.97	*36.4
F-18	420	600	*28.25	
Fe-59	934	1486	3.8	
Ga-67	53	424	53.8	
Hg-197	56	90	89.1	
Hg-203	237	322	44.8	
I-123	134	183	75.4	
I-125	23	80	*40	
I-131	309	420	*28.7	*45.19
In-111	146	490	* 60.0	*70.0
Ir-192	250	703	——	
K-42	1296	1754	——	
Lu-177	37	360	7.8	
Na-22	400	600	*23.6	*56.59
Na-24	1162	3167	——	
Pd-103	17	27	62.3	
Ra-223	40	430	135.9	
Ra-223 (Wipe)		430	**See note.	
Se-75	102	461	——	
Sr-85	437	591	18.2	
Tc-99m	119	162	*81.66	*83.95
Tc99-Tl-201	50	200	*68.3	
TI-201	50	100	*50.5	
Yb-169	41	228		

^{*}NOTE: It is recommended that users use the Empirical testing procedures for setting detector efficiency.

^{**}NOTE: Ra-223 Efficiency in the well counter varies depending on the type of sample placed into the well.

Ra-223 10 ml in a plastic vial is 141.2%.

Ra-223 1 ml in a plastic vial is 116.46%.

Ra-223 Wipe Smear in a plastic vial is 66.3%.

These are all with the Geometric Efficiency set to 96.82%.

Appendix B: Atomlab Wipe Test Counter Specifications

Display

Display: LCD Touch Panel 6.5" x 5", function keys are displayed for the operation being performed

Connectors: RJ-12 for well cable

Line Voltage: 100 to 240 VAC, auto selectable by the power supply, 1.5 - 0.75 amps

Line Frequency: 50/60 Hz, detachable line cord, built-in EMI filter and transient suppression

Auxiliary Port: Two USB ports, one RS-232 port

Memory: Stores wipe, calibration, background, high voltage, isotope specification,

isotope efficiency, Chi-Square testing results, technologist list, wipe locations list and latest MDA calculation. Results can be displayed and printed.

Preset Radionuclides: 27 including Tc-99m, Co-57, Cs-137, Ga-67, Tl-201, I-123, I-125, I-131, In-111, F-18

Power

This system uses XP Power Supply for medical use, Model #PDM60US15

Detector Cable

Length: Standard 8 ft. (243cm); custom cable lengths available up to 20 meters Conductors: Six total - 2 for power, two for chassis ground, two for serial data

Connectors: RJ-12

Well Counter

Detector: 2" x 2" NaI (T1) integral line scintillation detector with a 0.75" diameter x 1.44 " deep

well (1.9 x 3.7cm) Style: Remote Detector

Channels: 64

MCA: Integral to Well Counter Spectral Resolution: FWHM 10% Count Rate: (Maximum) 30,000 cps Connectors: RJ-12 for power and signal

Lead Shielding: 0.5" (1.2cm) integral lead shield

Optional Calibration Source: 0.1 µCi Cs-137 Rod Source

Optional Lead Shield: 0.5" (1.2cm) lead shield, slides over integral shield for total of

1.0" of shielding - includes cover

Cover: Fits optional lead shield, has 0.25" (.6cm) lead shielding

Environmental Operating Conditions

Temperature: 10 to 30°C

Humidity: 0 to 90% rh, non-condensing

For optimum performance, the Atomlab Wipe Test Counter should be operated in a normal laboratory environment where the temperature and humidity are maintained for normal human comfort and the ambient radiation level is low and constant.

Environmental Shipping and Storage Conditions

Temperature: 0 to 40°C

Humidity: 0 to 90% rh, non-condensing

For optimum performance, the Atomlab Wipe Test Counter should be operated in a normal laboratory environment where the temperature and humidity are maintained for normal human comfort and the ambient radiation level is low and constant.

Physical Data

Display Unit:

Size: 9.5"W x 12" H x 12" D (24.1 x 30.5 x 30.5cm)

Weight: 4.2 lb (1.9 kg)

Well Counter:

Size: 6"D x 11"H (15.24 x 27.9cm)

Weight: 29 lb (3.2 kg)

Approvals: ETL listed to UL 60601-1 and CAN/CSA C22.2 No. 601-1M90, IEC 60601-1,

IEC 60601-1-1, IEC 60601-1-4 and IEC 60601-1-2 and CE marked





Authorized European Community Representative:



Emergo Europe Molenstraat 15 2513 BH, The Hague The Netherlands

Appendix C: Atomlab Wipe Test Counter Display Diagnostics

Introduction

The color-touch screen display for the Atomlab Wipe Test Counter has built in, boot-up self diagnostics, along with real-time monitoring of the detector statuses. The wipe counter well itself performs real-time self tests, the results of which are reported back to the display approximately once per second. A Well Counter is an example of a type of detector supported.

The results of the display module's self-test are displayed during the display's power-up, as well as on-demand, shown on the System Test screen under Utilities, in the upper section of the display results. In addition, during normal operation detector status changes are handled by the display, reported on screen with a pop-up and audio tone alert, and actions taken based on the severity of the reported status.

The System Test screen displayed results are divided into two sections:

- · upper half is the display module's details (static result from boot-up)
- lower half lists diagnostic and status results for each identified detector, up to seven on an Atomlab 500 (1 Wipe Counter and 6 maximum Dose Calibrators). The display is dynamically updated in real-time, about once per second.

Real-Time Operating Detector Status Changes

During the course of normal operation, detectors report their status constantly to the display unit, including any detectable error conditions. The status reports come in as long the power to the display remains on, the detectors stay connected, and not in a severe fault state (communication error). So this means even if the detectors are not being used, or the display is blanked from the screen saver, the detectors are still communicating and being monitored.

For all newly reported error statuses, a Detector error reporting screen will appear with a 3 beep audio tone to alert the user. An error code will be displayed with its brief description. If the class of the error is FAIL, the detector will be automatically dropped from being selectable by the user, but the functions of the display for data management and configuration can still be used. If the class of the error is WARNING, the detector is still usable.

System Test Screen

The System Test screen is divided into two sections, where the upper half of the screen shows diagnostics of the display module unit itself from the boot-up self-diagnostics, and the lower half shows diagnostics relating to the detectors, dynamically updated while the detectors are connected and communicating.

Display Module Diagnostics Display (upper half)

There are 4 fields displayed in this section:

CPU Functions - result of testing the main processor's basic functionality (PASS/FAIL)

RAM Tests - results of performing 4 different tests on the integrity of the main memory chip, 8 MB of storage: stuck bit test for 0 and 1, alternating bit (cross over) test, and an addressing test

Firmware Check - displays the results of checking the CRC's of 3 different program loaded in flash memory: the Boot program, Main #1 program, and Main #2 program

Program Load - displays the results of checking the Boot configuration in flash memory (CRC'ed), and if it was required to changed the default program selected to load

Following is the possible displayed values:

CPU Functions PASS {all tests passing}

FAIL {at least 1 of the tests of the processor detected an error}

RAM Tests PASS {all 4 memory tests passing}

FAIL - Code: n {a memory test failed, see values below}

n=1: Stuck Bit test for 0 failedn=2: Stuck Bit test for 1 failedn=3: Alternating Bit test failedn=4: Addressing test failed

Firmware Check PASS (all 3 programs were read and verified using CRC-16)

WARN - Code: n {Error detected in Boot Program, see values below}

FAIL - Code: n-n-n {Error detected in Boot, Main #1, and/or Main #2}

n=0: no error detected

n=1: Parameter Block inconsistency

n=2: Parameter Block CRC-16 error detected

n=3: Program CRC-16 error detected

Program Load PASS - Loaded Program #n {n is 1 or 2}

WARNING – **Code n-n** {error detected, see values below}

1-0: Boot Configuration inconsistency

2-0: Boot Configuration CRC-16 error detected

0-1: the default program (#1 or #2) was invalid for some reason,

so the alternate program had to be loaded

1-1: combined errors: Boot Configuration inconsistency and invalid default

2-1: combined errors: Boot Configuration CRC-16 error and invalid default

Detector Diagnostics Display (lower half)

There are several properties of a Wipe Counter detector monitored and measured. The results are reported as a coded value, with an associated description. Space on the display is tight to accommodate up to 7 detectors, so if there's only 1 error in effect, we display the associated description. If there are multiple errors, we display only the codes. Here is the list of error codes, their class, and their description for Wipe Counters:

Error Code		Class Description
Code 1	FAIL	Firmware Checksum
Code 2	FAIL	EEPROM Data Corrupt
Code 3	FAIL	Communications Error
Code 4	FAIL	Could Not Set High Voltage

Following is the display status displays for the Wipe Counters:

PASS - no reported problems {no errors in effect, ready for measuring activity}

FAIL: n - <description>

FAIL: n-n-n {2 or more error codes may be present }

Failures (FAIL) are considered serious enough to not use the chamber for any activity measurements. The chamber will automatically be taken offline by the system, no longer selectable. Currently there are no WARNING class errors for Wipe Counter detectors. All 4 errors are FAIL class.

Chamber Error Code Descriptions

Code 1, Firmware Checksum

FAIL - The chamber's firmware has a checksum pre-calculated and stored, and it's verified during chamber power up. This error indicates the checksum calculated failed to match the checksum stored. Continuing to operate the chamber would be at risk. The chamber should be serviced.

Code 2, EEPROM Data Corrupt

FAIL - The chamber's stored data has a checksum pre-calculated and stored, and it's verified during chamber power up. This error indicates the checksum calculated failed to match the checksum stored for the appropriate stored data. Continuing to operate the chamber would be at risk. The chamber should be serviced.

Code 3, Communications Error

FAIL – This error code is set when repeated attempts of the display unit to communicate with a chamber failed. Once this error code is set, the display unit will no longer attempt to communicate with the chamber. This could be caused from a bad chamber or a bad or disconnected cable between the chamber and the display unit.

Code 4, Could Not Set High Voltage

FAIL - the Wipe Counter detector could not restore the previous High Voltage setting in effect, therefore making the Wipe Counter inaccurate to use. A power reset may clear the condition, but a High Voltage Adjustment is recommended before using the unit further. If the error persists, the chamber should be serviced.

Appendix D: Decay Calculations

This appendix provides methods of performing radioisotope decay calculations.

The first section provides two methods of performing Decay Calculations, the second section provides the Decay Factor Chart, and the third section provides an explanation of how the procedures used in the first section, and the Decay Factor Chart in the second section, are generated.

Decay Calculation Methods - Calculator Method

If you are using a calculator with the Y' function, perform the following:

- 1. Measure the current activity of the radioisotope (A_0) , which can be compared to the decayed calculated activity.
- 2. Look up the half life $T_{1/2}$ of the radioisotope in Appendix E. Note the time units.
- 3. $T_{1/2}$ = Half life of the isotope

t = Elapsed Time

A = Current Activity

 A_0 = Activity at the time of calibration

- 4. Calculate $A = A_0 \times 2^{(-t/T_{1/2})}$
- 5. Calculate the elapsed time (t) in the same units as the $(T_{1/2})$ that will elapse between when the calibrated activity measurement was made and when you wish to know what the decayed activity of your radioisotope will be.

Sample Calculation

The following is a calculation of the decayed activity of Tc-99m, with an initial activity of 43 mCi, after 53 minutes:

- 6. $A_0 = 43 \text{ mCi}$.
- 7. For Tc-99m, $T_{1/2} = 6.007 \text{ h}$.
- 8. Elapsed t = 53 min x $\frac{1 \text{ hr}}{60 \text{ min}}$ = 0.8833 h

9.
$$A = A_0 \times 2^{(-t/T_{1/2})}$$

$$A = 43 \text{ mCi } \times 2^{(-0.8833/6.007)}$$

$$A = 43 \text{ mCi } \times 2^{(-0.147045)}$$

$$A = 43 \ mCi \times 0.903$$

$$A = 38.83 \, mCi$$

Alternate Decay Calculation Method

If you are using a calculator with the Y function, perform the following:

- 1. Measure the current activity of the radioisotope (A₀), which can be compared to the decayed calculated activity.
- 2. Look up half life $(T_{1/2})$ of the radioisotope in Appendix E. Note the time units.

3.
$$T_{1/2}$$
 = Half life of the isotope

$$A_0$$
 = Activity at the time of calibration

4. Calculate
$$A = A_0 / 2^n$$

5. Calculate the elapsed time (t) in the same units as the $(T_{1/2})$ that will elapse between when the calculated activity measurement was made and when you wish to know what the decayed activity of your radioisotope will be.

Sample Calculation

6.
$$A_0 = 43$$
 mCi.

7. For Tc-99m,
$$T_{1/2} = 6.007 \text{ h}$$
.

8. Elapsed t = 53 min x
$$\frac{1 \text{ hr}}{60 \text{ min}}$$
 = 0.8833 hr

9. Replace equation with following:

$$A = A_0 / 2$$

$$A = A_0 / 2$$

 $A = 43 \text{ mCi } / 2$
 $A = 43 \text{ mCi } / 2$ (0.1470451)

$$A = 43 \text{ mCi} / 2$$

 $A = 43 \text{ mCi} / 2$ (0.1470451)

$$A = 43 \, mCi / 1.1072992$$

$$A = 38.83 \ mCi$$

Decay Factor Method

The following method is used to perform radioisotope decay calculations using a calculator without the e^x function:

- 1. Measure the current activity A_i of the radioisotope.
- 2. Look up half life $(T_{1/2})$ of the radioisotope. Note the time units.
- 3. Calculate the time \mathbf{t} , in the same units as $T_{1/2}$, that will elapse between when the activity measurement was made and when you wish to know what the decayed activity of your radioisotope will be.
- 4. Calculate $t / T_{1/2}$ in terms of N + R, where N is an integer (0, 1, 2, etc.) and R is less than 1.
- 5. Look up X_n (N) in Table 1.
- 6. Look up X_r (R) in the Decay Factor Chart.
- 7. Calculate $A_f = A_i \times X_n$ (N) $\times X_r$ (R).

Sample Calculation

The following is a calculation of the decayed activity of Tc-99m, with an initial activity of 43 mCi, after 32.5 hours:

- 1. $A_i = 43 \, mCi$.
- 2. For Tc-99m, $T_{1/2} = 6.007 \text{ h}$.
- 3. t = 32.5 h.
- 4. $t / T_{1/2} = 32.5 \text{ h} / 6.007 = 5.410. \text{ N} = 5, \text{ R} = 0.410.$
- 5. From Table 1, X_n (5) = 0.03125.
- 6. From the Decay Factor Chart, the .41 row and the .000 column, X_r (.410) = .75262.
- 7. $A_f = A_i \times X_n$ (N) $\times X_r$ (R) = 43 $mCi \times (0.03125) \times (.75262) = 1.01 <math>mCi$.

N	$X_n (N) = 2^{-N}$	
0	1	
1	0.5	
2	0.25	
3	0.125	
4	0.0625	
5	0.03125	
6	0.01563	
7	0.007813	
8	0.003906	
9	0.001953	
10	0.000977	

Table 1

DECAY FACTOR CHART

 X_r (R), where R = t / $T_{1/2}$ (0.000 to 0.499)

```
.002
         .000
                .001
                              .003
                                     .004
                                          .005
                                                   .006
R
                                                          .007
                                                                 .008
.00
       1.00000 .99931 .99861 .99792 .99723 .99654 .99585 .99516 .99447 .99378
.01
        .99309 .99240 .99172 .99103 .99034 .98966 .98897 .98829 .98760 .98692
.02
        .98623 .98555 .98487 .98418 .98350 .98282 .98214 .98146 .98078 .98010
.03
        .97942 .97874 .97806 .97739 .97671 .97603 .97536 .97468 .97400 .97333
        .97265 .97198 .97131 .97063 .96996 .96929 .96862 .96795 .96728 .96661
.04
.05
        .96594 .96527 .96460 .96393 .96326 .96259 .96193 .96126 .96059 .95993
        .95926 .95860 .95794 .95727 .95661 .95595 .95528 .95462 .95396 .95330
.06
.07
        .95264 .95198 .95132 .95066 .95000 .94934 .94868 .94803 .94737 .94671
.08
        .94606 .94540 .94475 .94409 .94344 .94278 .94213 .94148 .94083 .94017
.09
        .93952 .93887 .93822 .93757 .93692 .93627 .93562 .93498 .93433 .93368
        .93303 .93239 .93174 .93109 .93045 .92980 .92916 .92852 .92787 .92723
.10
        .92659 .92595 .92530 .92477 .92402 .92338 .92274 .92210 .92146 .92083
.11
.12
        .91447 .91510 .91854 .91700 .91637 .91573 .91510 .91447
.13
        .91383 .91320 .91257 .91193 .91130 .91067 .91004 .90941 .90878 .90815
        .90752 .90689 .90626 .90563 .90501 .90438 .90375 .90313 .90250 .90188
.14
.15
        .90125 .90063 .90000 .89938 .89876 .89813 .89751 .89689 .89627 .89565
.16
        .89503 .89440 .89379 .89317 .89255 .89193 .89131 .89069 .89008 .88946
.17
        .88884 .88823 .88761 .88700 .88638 .88577 .88515 .88454 .88393 .88332
.18
        .88270 .88209 .88148 .88087 .88026 .87965 .87904 .87843 .87782 .87721
        .87661 .87600 .87539 .87478 .87418 .87357 .87297 .87236 .87176 .87115
.19
.20
        .87055 .86995 .86934 .86874 .86814 .86754 .86694 .86634 .86574 .86514
        .86454 .86394 .86334 .86274 .86214 .86155 .86095 .86035 .85976 .85916
.21
.22
        .85857 .85797 .85738 .85678 .85619 .85559 .85500 .85441 .85382 .85323
.23
        .85263 .85204 .85145 .85086 .85027 .84968 .84910 .84851 .84792 .84733
.24
        .84675 .84616 .84557 .84499 .84440 .84382 .84323 .84265 .84206 .84148
        .84090 .84031 .83973 .83915 .83857 .83799 .83741 .83683 .83625 .83567
.25
        .83509 .83451 .83393 .83335 .83278 .83220 .83162 .83105 .83047 .82989
.26
.27
        .82932 .82874 .82817 .82760 .82702 .82645 .82588 .82531 .82473 .82416
        .82359 .82302 .82245 .82188 .82131 .82074 .82017 .81960 .81904 .81847
.28
.29
        .81790 .81734 .81677 .81620 .81564 .81507 .81451 .81394 .81338 .81282
        .81225 .81169 .81113 .81057 .81000 .80944 .80888 .80832 .80776 .80720
.30
.31
        .80664 .80608 .80552 .80497 .80441 .80385 .80329 .80274 .80218 .80163
        .80107 .80051 .79996 .79941 .79885 .79830 .79775 .79719 .79664 .79609
.32
        .79554 .79499 .79443 .79388 .79333 .79278 .79223 .79169 .79114 .79059
.33
        .79004 .78949 .78895 .78840 .78785 .78731 .78676 .78622 .78567 .78513
.34
.35
        .78458 .78404 .78350 .78295 .78241 .78187 .78133 .78079 .78025 .77970
        .77916 .77862 .77809 .77755 .77701 .77647 .77593 .77539 .77486 .77432
.36
.37
        .77378 .77325 .77271 .77218 .77164 .77111 .77057 .77004 .76950 .76897
.38
        .76844 .76791 .76737 .76684 .76631 .76578 .76525 .76472 .76419 .76366
        .76313 .76260 .76207 .76154 .76102 .76049 .75996 .75944 .75891 .75838
.39
        .75786 .75733 .75681 .75628 .75576 .75524 .75471 .75419 .75367 .75315
.40
.41
        .75262 .75210 .75158 .75106 .75054 .75002 .74950 .74898 .74846 .74794
.42
        .74742 .74691 .74639 .74587 .74536 .74484 .74432 .74381 .74329 .74278
        .74226 .74175 .74123 .74072 .74021 .73969 .73918 .73867 .73816 .73765
.43
        .73713 .73662 .73611 .73560 .73509 .73458 .73408 .73357 .73306 .73255
.44
        .73204 .73154 .73103 .73052 .73002 .72951 .72900 .72850 .72799 .72749
.45
.46
        .72699 .72648 .72598 .72548 .72497 .72447 .72397 .72347 .72297 .72247
        .72196 .72146 .72096 .72047 .71997 .71947 .71897 .71847 .71797 .71747
.47
        .71698 .71648 .71598 .71549 .71499 .71450 .71400 .71351 .71301 .71252
.48
.49
        .71203 .71153 .71104 .71055 .71005 .70956 .70907 .70858 .70809 .70760
```

DECAY FACTOR CHART X_r (R), where R = t / $T_{1/2}$ (0.500 to 1.0)

R	.000	.001	.002	.003	.004	.005	.006	.007	.008	.009
.50	.70711	.70662	.70613	.70564	.70515	.70466	.70417	.70368	.70320	.70271
.51	.70222	.70174	.70125	.70076	.70028	.69979	.69931	.69882	.69834	.69786
.52	.69737	.69689	.69641	.69592	.69544	.69496	.69448	.69400	.69352	.69304
.53				.69112						
.54				.68634						
.55				.68160						
.56				.67689						
.57				.67222						
.58				.66757						
.59				.66296						
.60				.65838						
.61				.65384						
.62				.64932						
.63				.64483						
.64				.64038						
.65				.63596						
.66				.63156						
.67				.62720						
.68 .69				.62287 .61857						
.70				.61429						
.70				.61005						
.71				.60584						
.72				.60165						
.73				.59750						
.75				.59337						
.76				.58927						
.77				.58520						
.78				.58116						
.79				.57714						
.80				.57316						
.81				.56920						
.82	.56644	.56605	.56566	.56527	.56487	.56448	.56409	.56370	.56331	.56292
.83	.56253	.56214	.56175	.56136	.56097	.56058	.56019	.55981	.55942	.55903
.84	.55864	.55826	.55787	.55748	.55710	.55671	.55632	.55594	.55555	.55517
.85				.55363						
.86				.54981						
.87	_			.54601					_	
.88				.54224						
.89				.53849						
.90				.53477						
.91				.53108						
.92				.52741						
.93				.52377						
.94				.52015						
.95				.51656						
.96				.51299						
.97 .98				.50945 .50593						
.98				.50243						
1.0	.50000	. 10013	.30276	.30243	.30208	.30174	.50159	.50104	.50009	.50055
1.0	.50000									

Explanation of Decay Calculation Methods

Calculator Method

The radioactivity of an isotope can be calculated as it decays using the following expression:

$$A_f = A_i e^{-\lambda t}$$

where

 A_f = final activity at the end of the decay time;

A_i = initial activity measured at some starting time;

 $t = net decay time in units inverse to <math>\lambda$; and

 λ = (lamda) decay constant specific to the radioisotope.

$$\lambda = \ln (2) / T_{1/2} = 0.693 / T_{1/2}$$

where

 $T_{1/2}$ = half life specific to the radioisotope.

So, using a calculator with the e^x function, decay calculations can easily be performed, as shown in the first section of this appendix.

Decay Factor Method

If you do not have a calculator with the \mathbf{e}^{x} function, the above expression can be rewritten as follows:

$$A_f = X A_i$$

where

$$X = X_n(N) \times X_r(R)$$

N = integer number of half lives in time t; and

R = decimal remainder after dividing t by $T_{1/2}$. To verify this, remember three important relations regarding exponentials:

$$e^{(A + B)} = e^A \times e^B$$
:

$$e^{ln(A)} = A$$
; and

$$e^{AB} = (e^A)^B$$
.

Now $t / T_{1/2} = N + R$

where N is an integer, and R is the remainder less than 1.

For t = 32.5 hours and $T_{1/2} = 6.007$ hours,

$$t / T_{1/2} = 32.5 / 6.007 = 5.410$$

so that N = 5 and R = 0.410.

Now, to simplify calculations, we can write the above relation as:

$$A_f = A_i e^{-\lambda t} = A_i e^{-\ln{(2)t}} / T_{1/2}$$

$$A_f = A_i e^{-\ln{(2)(N+R)}} = A_i e^{-\ln{(2)N}} x e^{-\ln{(2)R}}$$

$$= A_i \times X_n (N) \times X_r (R)$$

$$X_n(N) = e^{-\ln{(2)N}} = (e^{\ln{(2)}})^{-N} = 2^{-N}$$

This expression is used to generate the values in Table 1.

$$X_r(R) = e^{-\ln{(2)R}}$$

This expression is used to generate the Decay Factor Chart for values of R from 0.001 to 0.999 for the above example

$$X_n(5) = 0.03125$$

$$X_r(0.410) = 0.75262$$

$$A_f = X A_i = [X_n (N) \times X_r (R)] A_i = [0.03125 \times 0.75262] 43 \text{ mCi}$$

$$A_f = 1.01 \text{ mCi}$$

Appendix E: Atomlab Wipe Test Counter Serial Communications Interface

The Atomlab Wipe Test Counter has the ability to be controlled and monitored, with limitations, via the DB-9 RS-232 serial port.

Connection Details:

Cable:RS-232 female/female Null Modem, for connection to a standard PC COM Port

Port Settings: 19.2 KBAUD, no parity, 1 stop

Command Format:

All commands are in ASCII format, terminated by a Carriage Return (0x0D), and no longer than 7 letters. If a parameter is given, the command must be separated from the parameter by at least 1 space and/or comma. If the command or parameter has a format error, or a numeric parameter is out of range, an error message is sent out the serial port, terminated by a CR/LF. All data transmitted as a result of a command is also in ASCII and terminated by a CR/LF.

Usage Notes:

Some of these commands that actively change settings and operation of the display can cause corruption of an activity someone may be in progress of at the display console. These remote commands must be used with great care and consideration of how the unit is being used. The ISO command, for example, when used to change an isotope is fine on a detector not in use, but if a QA test is in progress for a sealed source and the ISO command changes the isotope, the displayed activity will be out of sync with the displayed isotope symbol name.

Command Descriptions:

There are commands to report status, and some control the unit. Following is a list with descriptions in alphabetic order.

^C (Hex: 0x03) Sends the most current activity reading out the serial port. A Carriage Return (0x0D) is not required. This is implemented for backwards compatibility with the AtomLab 100/200 models. Please refer to the DS command for details of the activity report format.

1 (Hex: 0x31) same as ^C above. A Carriage Return (0x0D) is not required.

BAUD # Sets the baud rate of this serial port, where 1 = 19.2k baud,

2 = 38k baud. 3 = 56k baud. and 4 = 115 baud.

BEEP ### Issues a beep tone on the display for "###" milliseconds. If not

specified, it defaults to 100. Longest beep sounded can be for 10 seconds.

BKGND $\{\#\}$ where #=1..7 (Detector #)

(For a Dose Calibrator Only)

This command will do a Zero Background on the specified detector number. If no parameter is given, it will use Detector #1. If the command cannot be performed, one of the following errors will be returned:

ERROR: Cannot Display Zero Background {a "modal" screen is being viewed, blocking the view of Zero Background}

ERROR: Invalid Detector Number {the detector # specified cannot be found, or is not available}

If the command succeeds, it may be done instantly, taking effect on the very next activity reading, or may take up to 100 readings. If the Zero Background does not happen instantly, each reading from that detector will be preceded by:

~ Calculating background... {Followed by CR/LF}

When this command is received, the Zero Background screen will be displayed for that detector. However if there is a "modal" style screen displayed, our GUI package will not allow another screen to pop up over it, so in this case, we will return an error. There are not many modal screens, but examples are the QWERTY keyboard screen, the numeric keypad screen, Select Sealed Source, Select Detector, Set Date/Time, etc.

CAPSCR {0/1} Captures the screen to the local Hard Disk (=0), or to a USB Flash Drive (=1).

This operation takes a snap shot of the current display screen and captures it to a BMP file. It may take a few seconds to complete. If no parameter is given,

it defaults to 0 (local Hard Disk).

COUNTRY # Sets or displays the current country setting, used for formatting

dates and times, and configuring the keyboard screen. Currently, translations of the screens is not available. The choices are: US, Can, Fra, Ger, Ita, Jpn,

Spa, UK

DBGLOG {1/0} (For a Dose Calibrator Only)

Detector Debug Logging On=1, Off=0. Default to Off. When On, every time a reading is reported from a detector, it's raw current value is reported out the serial port (streaming mode). This continues until it's turned off. If there is more than 1 detector connected, the detector number is appended on the

end of each report.

DCNT Display the number of active, connected detectors

DMPSCR # Dumps the content of the screen in a binary format out to the

serial port.

DS {1/0} (For a Dose Calibrator Only)

Turns Data Streaming Mode On=1, Off=0. If no parameter is

given, the current Data Streaming Mode is displayed. When On, every time a reading is reported from a detector, the isotope's symbol, dial values, and activity reading is reported continuously until turned off. If there is more than 1 detector connected, the detector number is appended on the end of each report. The report starts with a tilda (~) character with the fields separated by a space. The activity reading always has 3 decimal digits in the report followed by the units. Here is an example of a report: ~Tc-99m 37.1 1404.767 μ Ci

DSMODE {#} (For a Dose Calibrator Only)

Configures Data Streaming Mode for all or a specific detector, where All=0,

1..n is the detector number.

DSTAT {#} Displays Detector Status of all or a specific detector. If no parameter is given,

it will default to all detectors, while 1..n is the detector number.

The data returned for a Dose Calibrator is as follows in this order: Detector Id, High Voltage, Pressure, Temperature, Argon gas (grams)

The data returned for a Wipe Test detector is as follows in this order:

Detector Id, Current High Voltage, Last Saved High Voltage,

Channel # Cs-137 peak was detected at

If there are multiple detectors connected, an additional field is added - the

detector number.

Here is an example of the returned data for an Atomlab 500Plus:

8 359.4 260.2 21.3 7.4 1 14 1188.0 1188.0 52 2

DT {#} Display or Set the Date/Time. If no parameter is given, the

current Date/Time is displayed in US 24hr format. For setting the Date/Time, the display's current date/time is updated and the Real-Time clock updated. The date/time parameter must be in standard US 24hr format as follows:

mm/dd/yyyy hh:mm:ss

ECHO {1/0} Display or turn local character echo On (=1) or Off (=0). Local

character echo is On by default. If using data streaming, this should be

turned Off to avoid mangling the streaming reports.

HELP Same as the "?" command, displays all available commands

with a brief description.

ISO {#}{-#} (For a Dose Calibrator Only)

Displays or sets the Isotope assigned to a detector. For a single detector system, the 2nd parameter is not required. The 1st parameter is an isotope index number, 1 to 88 for the default isotopes, 89 to 113 for custom isotopes. Refer to the separate Isotope Index document at the end of this chapter for details. The 2nd parameter is the detector number. If no parameter is given, the current assigned isotope for each detector is displayed. Use this command with great care - if the display is in use doing a QA test, this command can corrupt the current running test.

Example of a command:

ISO 43 {sets isotope Tc-99m for detector #2}

The Following errors may be returned:

ERROR: Invalid Isotope Index # { a number greater than 90 was specified } ERROR: Measure Screen Not Active { the Measure screen must be on view for this command to work }

When this command is received, the newly selected isotope will be displayed, and the activity changed accordingly. However if any screen other than the Measure screen is on view, the isotope cannot be changed, and the displayed screen will not be affected.

NOTE: Reference Isotope Index # Table for programming.

PRTSCR Prints the current displayed screen on the HP inkjet printer

PWD {1/0} Sets the screen password override (1=Override, 0=entry

required). If no parameter is given, the current state of the password override

is displayed.

OADATA Displays a summary of stored QA Data Records. For each QA data type, the

allocated space and used space is shown.

REQDATA {QAType} {LocationType} {Date-Range}

Where:

QA Type: set to "ALL" or 1 of 11 data types: CON, GEO, ACC, DEC, LIN, CAL, HVA, CLB, BCK, WIP, CHI, or WCN

Location Type: if the QA Type is "WIP", then Location Type can be "ALL" or AREA (Restricted or Unrestricted), SRC (Sealed Source), or PKG (Package)

Date-Range: "From-To" for a date range or a date for a single day. A date is in the format of "mm/dd/yy" or can be "mm/dd" assuming the current year

Examples:

REQDATA WIP AREA 05/01-05/31

{get all the Restricted/Unrestricted wipe results for the month of May }

REQDATA BCK 05/22

{get all the wipe background results from May 22nd }

REQDATA ALL

{all recorded data }

REQDATA ALL 03/21/2009

{all data recorded on one day: 03/21/2009 }

The QA Type's are defined as:

CON - Daily and Expanded Constancy, **GEO** - Geometry, **ACC** - Accuracy,

DEC - Decay, **LIN** - Lineator,

CAL - Calicheck, HVA - wipe High Voltage Adjustment,

CLB - wipe Daily Calibration, **BCK** - wipe Background,

WIP - Wipe Tests, CHI - Chi-Square

WCN - Wipe Test Constancy

The first item returned will be a CR/LF terminated line:

n Records { count of records being sent }

Followed by the actual records in the current export format. If there are no records meeting the criteria, all that is returned would be: 0 Records

For the Wipe Test data, a line will be added immediately after the Location line for the Location Type:

Type,"Location Type" where "Location Type" can be Restricted, Unrestricted, Sealed Source, or Package

Also, the Wide Window Background CPM value is currently being exported (I didn't realized this before). It's in the Wide Window record. Here is an example of the Wide Window record with a brief description of the fields:

WideWindow, Cs-137,40 DPM, 14.0,1039 DPM, 20000 DPM, Ok, 35.24, 25-800 keV

Where:

Cs-137: isotope name assigned for the wide window

40 DPM: wide window net count in DPM

14.0: wide window net count in CPM1039 DPM: Background CPM for the wide window

20000 DPM: trigger level for the wide window

Ok: status of the wide window (Ok or OVER)

35.24: total efficiency of the wide window

25-800 keV: ROI of the wide window

RESET Immediately re-starts the Atomlab firmware program.

SETID #-# Changes a detector Id specified as "from-to". Valid Id's are: 2, 4, 6, 8, 10, 12,

and 14.

SMP {#} Displays details on an inventory sample number. If no

parameter is given, the number of stored samples is displayed.

SSAV # Sets the screen saver time in seconds. It's in effect only until

the next reboot, then the configured screen saver takes effect. If no parame-

ter is given, it displays the current screen saver time in effect.

SSRC {#} Deletes the specified sealed source number. If no parameter is

given, a summary of the current defined sealed sources is displayed.

STAT {1/0} This is for more advanced detector status viewing. This

command will turn on an on-screen display of detector status on the Count screen (1=Set On, 0=Turn Off). If no parameter is given, a detailed state of

the current connected detectors is displayed.

VER Displays the Atomlab display unit's firmware versions as follows:

UDM Vers: 1.22 10/12/2010 Windows CE 6.0 Based System

Appendix F:

Conformance to Standards

This equipment conforms to the following safety standards:

Standard	Edition and/or date
IEC60601-1-2	First edition, 2007

Table 1.1. Safety standards

Accompanying EMC Documents

This medical electrical equipment needs special precautions regarding EMC and needs to be installed and put into service according to the EMC information provided in this manual.

- · Portable and mobile RF communications equipment can affect medical electrical equipment.
- Use of accessories, transducers and cables other than those specified, with the ex-ception
 of accessories, transducers and cables sold by the manufacturer of this equipment, as replacement parts for internal and external components, may result in increased emissions or
 decreased immunity of the equipment.
- The AL Wipe Test Counter should not be used adjacent to or stacked with other equipment. If the AL Wipe Test Counter is used while positioned adjacent to other equipment, it should be observed to verify normal operation in the configuration in which it will be used.

List of Cable Accessories

The list in Table 1.2 includes all accessory cables supplied with the AL Wipe Test Counter for which the manufacturer of this equipment claims compliance to EN 60601-1-2 when used with the AL Wipe Test Counter.

Cable description	Part no.	Cable length
Power Input Wall Pack	Biodex # C13116	6ft
Nema Cord Set	Biodex # C11789	10ft

Table 1.2. AL 500 cables

Declaration of Conformity

Emissions

AL Wipe Test Counter		e electromagnetic environment specified below. The customer or the user of the in such an environment.
Emission test	Compliance	Electromagnetic environment
RF emissions CISPR 11	Group 1	The AL Wipe Test Counter generates RF energy only for its internal functions. Therefore, its RF emission is very low and is not likely to cause any interference in nearby electronic equipment
RF emissions CISPR 11	Class A	The AL Wipe Test Counter is suitable for use in all establishments other than domestic and those directly connected to the public low-voltage power supply network supplying buildings used for domestic purposes.
Harmonic distortion EN 61000-3-2	Class A	
Voltage fluctuations and flicker EN 61000-3-3	Complies	

Note. It is essential that the actual shielding effectiveness and filter attenuation of the shielded location be verified to assure that they meet the minimum specifications

Immunity

Manufacturer's declar	ation electromagnetic immur	nity	
	nter is intended for use in the e ounter should assure that it is u	-	nent specified below. The customer or the user nent.
Immunity test	IEC 60601-1-2 Test level	IEC 60601-1-2 Compliance level	Electromagnetic environment – guidance
Electrostatic discharge (ESD) IEC 61000-4-2	± 6 kV contact ± 8 kV air	Contact ± 6 kV Air ± 8 kV	Floor should be wood, concrete or ceramic tiles. If floor is covered with synthetic material, the relative humidity should be at least 30%
Electrical fast transients/burst IEC 61000-4-4	± 2 kV for power lines ± 1 kV for input/output lines	Power ± 2 kV Signal ± 1 kV	Mains power quality should be that of a typical commercial or hospital environment
Surge IEC 61000-4-5	± 1 kV differential mode ± 2 kV common mode	± 1 kV diff. mode ± 2 kV com. mode	Mains power quality should be that of a typical commercial or hospital environment

Immunity test	IEC 60601-1-2 Test level	IEC 60601-1-2 Compliance level	Electromagnetic environment – guidance
Voltage dips, short interruptions and voltage variations on power supply input lines IEC 61000-4-11	<5% UT (> 95% of dip in UT) for 1/2 cycle 40% UT (60% of dip in UT) for 5 cycle 70% UT (30% of dip in UT) for 25 cycle <5% UT (> 95% of dip in UT) for 5 sec	< 5% UT (> 95% of dip in UT) for 1/2 cycle 40% UT (60% of dip in UT) for 5 cycle 70% UT (30% of dip in UT) for 25 cycle < 5% UT (> 95% of dip in UT) for 5 sec	Mains power quality should be that of a typical commercial or hospital environment. If a better mains power quality is required, it is recommended that the AL 500 is powered from an uninterruptible power supply
Power frequency (50/60 Hz) magnetic field IEC 61000-4-8	3 A/m	3 A/m	If image distortion occurs, it may be necessary to position the AL 500 display further from sources of power frequency magnetic fields or to install magnetic shielding. The power frequency magnetic field should be measured in the intended installation location to assure that it is sufficiently low
22.7.8.7.7.7.7.7.7.7.7.7.7.7.7.7.7.7.7.7		3 Vrms, 150KHz to 80 MHz	Portable and mobile RF communications equipment should be used no closer to any part
Radiated RF IEC 61000-4-3	3 V/m, 80 MHz to2.5 GHz	3 V/m, 80 MHz to2.5 GHz	of the AL 500, including cables, than the recommended separation distance calculated from the equation applicable to the frequency of the transmitter. Recommended separation distance: d = 1.2√P 150 KHz to 80 MHz d = 1.2√P 80 MHz to 800 MHz d = 2.3√P 800 MHz to 2.5 GHz where P is the maximum output power rating of the transmitter in watt (W) according to the transmitter manufacturer, and d is the recommended separation distance in meters (m). Field strengths from fixed RF transmitters, as determined by an electromagnetic site survey, should be less than the compliance level in each frequency range. Interference may occur in the vicinity of equipment marked with the following symbol:

Note 1. UT is the a.c. mains voltage prior to application of the test level.

Note 2. At 80 MHz and 800 MHz, the higher frequency range applies.

Note 3. These guidelines may not apply in all situations. Electromagnetic propagation is affected by absorption and reflections from structures, objects and people

^a Field strength from mixed transmitters, such as base stations for radio telephones and land mobile radios, amateur radio, AM or FM broadcast and TV broadcast cannot be predicted theoretically with accuracy. To assess the electromagnetic environment due to fixed RF transmitters, an electromagnetic site survey should be considered. If the measured field strength in the location in which the AL 500 is used exceeds the applicable RF compliance levels above, the AL 500 should be observed to verify normal operation. If abnormal performance is observed, additional measures may be necessary, such as reorienting or relocating the AL 500. ^b Over the frequency range 150 KHz to 80 MHz, field strengths should be less than 3 V/m.

Recommended Separation Distances

Recommended separation distances between portable and mobile RF communications equipment and the AL 500. Table 6

The AL 500 is intended for use in the electromagnetic environment in which radiated RF disturbance are controlled. The customer or the user of the AL 500 can help prevent electromagnetic interference by maintaining a minimum distance between portable and mobile RF communication equipment (transmitters) and the AL 500 as recommended below, according to the maximum output power of the communication equipment.

Rated maximum output	Separation distance according to frequency of transmitter [m]				
power of transmitter [W]	150 kHz to 80 MHz d = 1.2√ P	80 MHz to 800 MHz d = 1.2√ P	800 MHz to 2.5 GHz $d = 2.3 \sqrt{P}$		
0.01	0.12	0.12	0.23		
0.1	0.38	0.38	0.73		
1	1.2	1.2	2.3		
10	3.8	3.8	7.3		
100	12	12	23		

For transmitters rated at a maximum output power not listed above, the recommended separation distance d in meters (m) can be estimated using the equation applicable to the frequency of the transmitter, where P is the maximum output power rating of the transmitter in watts (W) according to the transmitter manufacturer.

Note 1. At 80 MHz and 800 MHz, the separation distance for the higher frequency range applies.

Note 2. These guidelines may not apply in all situations. Electromagnetic propagation is affected by absorption and reflection from structures, objects and people.

Appendix G: Glossary

Following are several definitions for common terms relevant to the Atomlab Wipe Test Counter:

Background Correction

This value, derived by taking a background measurement, is automatically subtracted from all subsequent activity measurements to compensate for the background activity level.

Calibration

The use of calibrated activity sources traceable to the National Institute of Standards & Technology to calibrate each Atomlab 500 Wipe Counter unit and determine the efficiencies for various isotopes.

Decay Chart

A chart projecting how the activity of a source will decay over a period of time at specified time intervals.

L-Block Shield

A partially transparent radiation shield behind which doses can be prepared.

NIST

National Institute of Standards & Technology, whose activities include maintaining radioactive material standards.

NRC

Nuclear Regulatory Commission, which is the agency of the federal government which regulates radioactive materials.

Minimum Detectable Activity (MDA)

The smallest activity that can be detected by an instrument for a specific radionuclide with a defined region of interest.

Chi-Square

A test used to determine whether random variations in a set of measurements are consistent with what would be expected for a Poisson distribution.

High Voltage

High voltage is current which is applied to the photomultiplier tube to multiply the current.

Well Detector

This is a drilled sodium iodide detector.

Appendix H: Atomlab Wipe Test Counter Replacment Parts

Atomlab Wipe Test Counter Replacement Parts

(See Figure H.1)

C13116	POWER SUPPLY
C11789	CORD SET
C10547	THREE LOBE KNOB
086-330-E102	UNIVERSAL MEMBRANE SWITCH
C10320	ON/OFF SWITCH
950-385-E802	TFT DISPLAY ASSEMBLY
950-385-E840	LCD DISPLAY BOARD
C12696	LCD INVERTER
086-241	WELL INSERT
086-242	WELL VIAL/SYRINGE DIPPER
086-330-E705	CHAMBER CABLE, 8 FEET
C8187	BUMPONS, SELF ADHESIVE, GREY
086-345	CHAMBER CABLE, 15 FEET

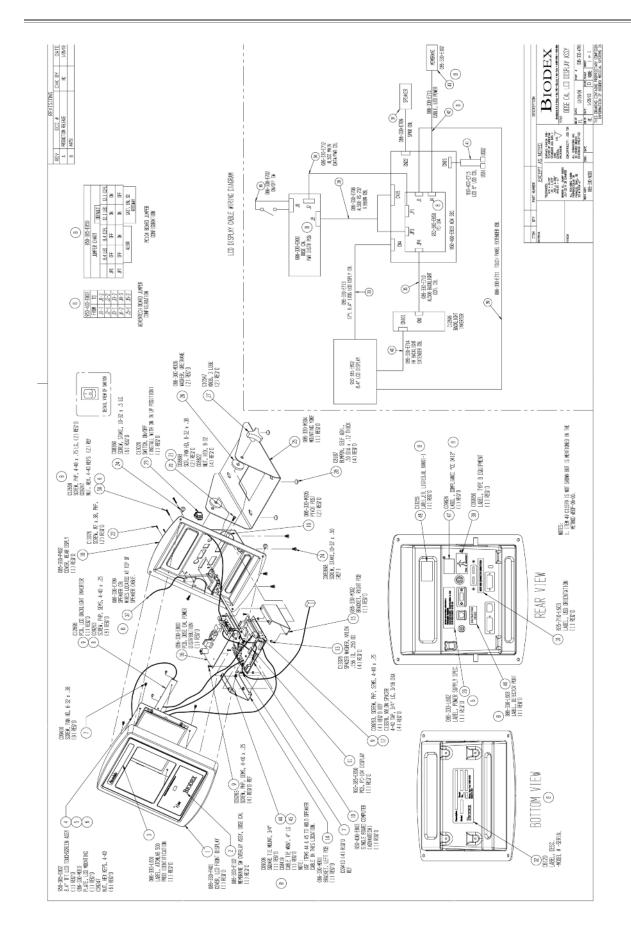


Figure H.1. Atomlab Wipe Test Counter replacement parts.

Appendix I: Schematics



